

SIEMENS

Microcomputer Components

8-Bit CMOS Single-Chip Microcontroller

SAB 80C517A/83C517A-5

High-Performance 8-Bit CMOS Single-Chip Microcontroller

SAB 80C517A/83C517A-5

Preliminary

SAB 83C517A-5
SAB 80C517A

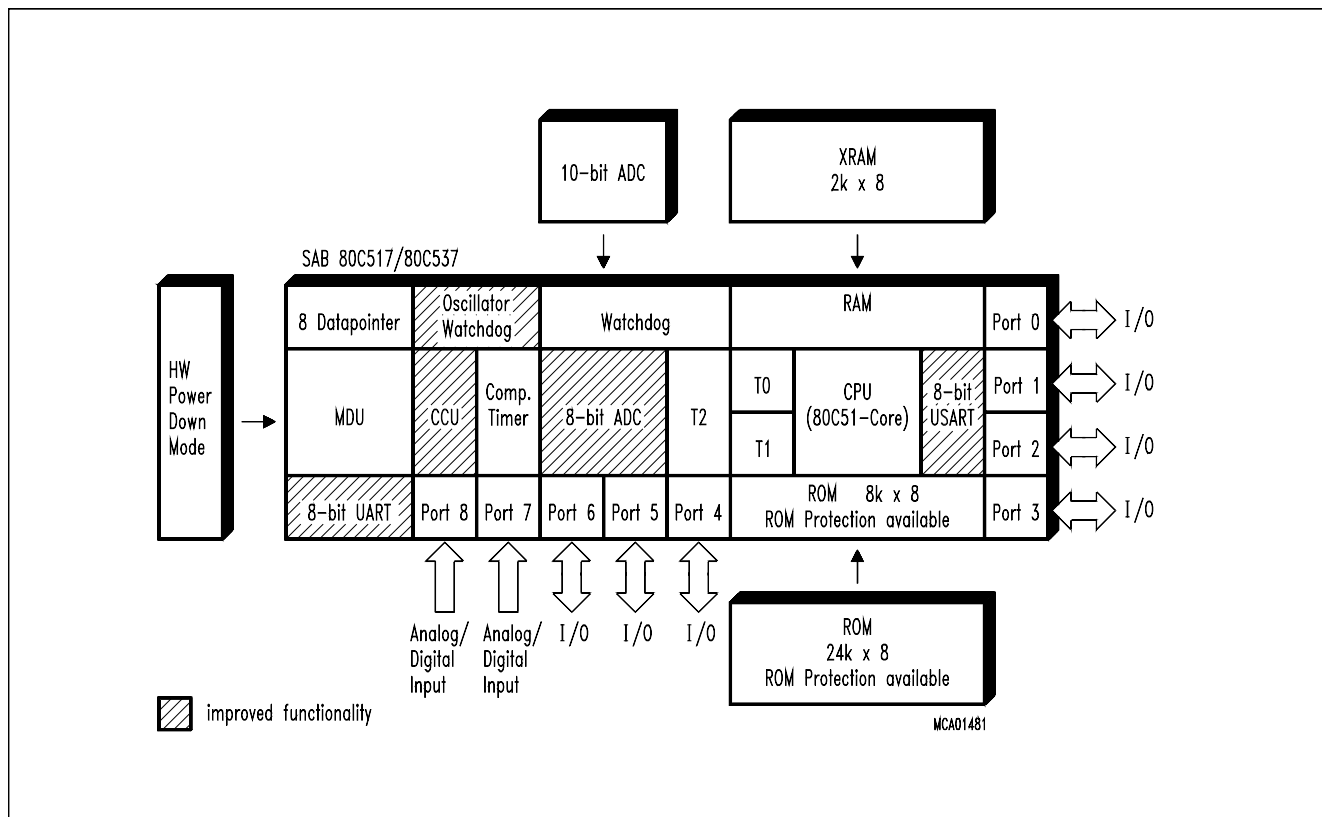
Microcontroller with factory mask-programmable ROM
Microcontroller for external ROM

- SAB 80C517A/83C517A-5, up to 18 MHz operation
- 32 K × 8 ROM (SAB 83C517A-5 only, ROM-Protection available)
- 256 × 8 on-chip RAM
- 2 K × 8 on-chip RAM (XRAM)
- Superset of SAB 80C51 architecture:
 - 1 μs instruction cycle time at 12 MHz
 - 666 ns instruction cycle time at 18 MHz
 - 256 directly addressable bits
 - Boolean processor
 - 64 Kbyte external data and program memory addressing
- Four 16-bit timer/counters
- Powerful 16-bit compare/capture unit (CCU) with up to 21 high-speed or PWM output channels and 5 capture inputs
- Versatile "fail-safe" provisions
- Fast 32-bit division, 16-bit multiplication, 32-bit normalize and shift by peripheral MUL/DIV unit (MDU)
- Eight data pointers for external memory addressing
- Seventeen interrupt vectors, four priority levels selectable
- Genuine 10-bit A/D converter with 12 multiplexed inputs
- Two full duplex serial interfaces with programmable Baudrate-Generators
- Fully upward compatible with SAB 80C515, SAB 80C517, SAB 80C515A
- Extended power saving mode
- Fast Power-On Reset
- Nine ports: 56 I/O lines, 12 input lines
- Three temperature ranges available:
 - 0 to 70 °C (T1)
 - 40 to 85°C (T3)
 - 40 to 110°C (T4)
- Plastic packages: P-LCC-84, P-MQFP-100-2

The SAB 80C517A/83C517A-5 is a high-end member of the Siemens SAB 8051 family of microcontrollers. It is designed in Siemens ACMOS technology and based on SAB 8051 architecture. ACMOS is a technology which combines high-speed and density characteristics with low-power consumption or dissipation.

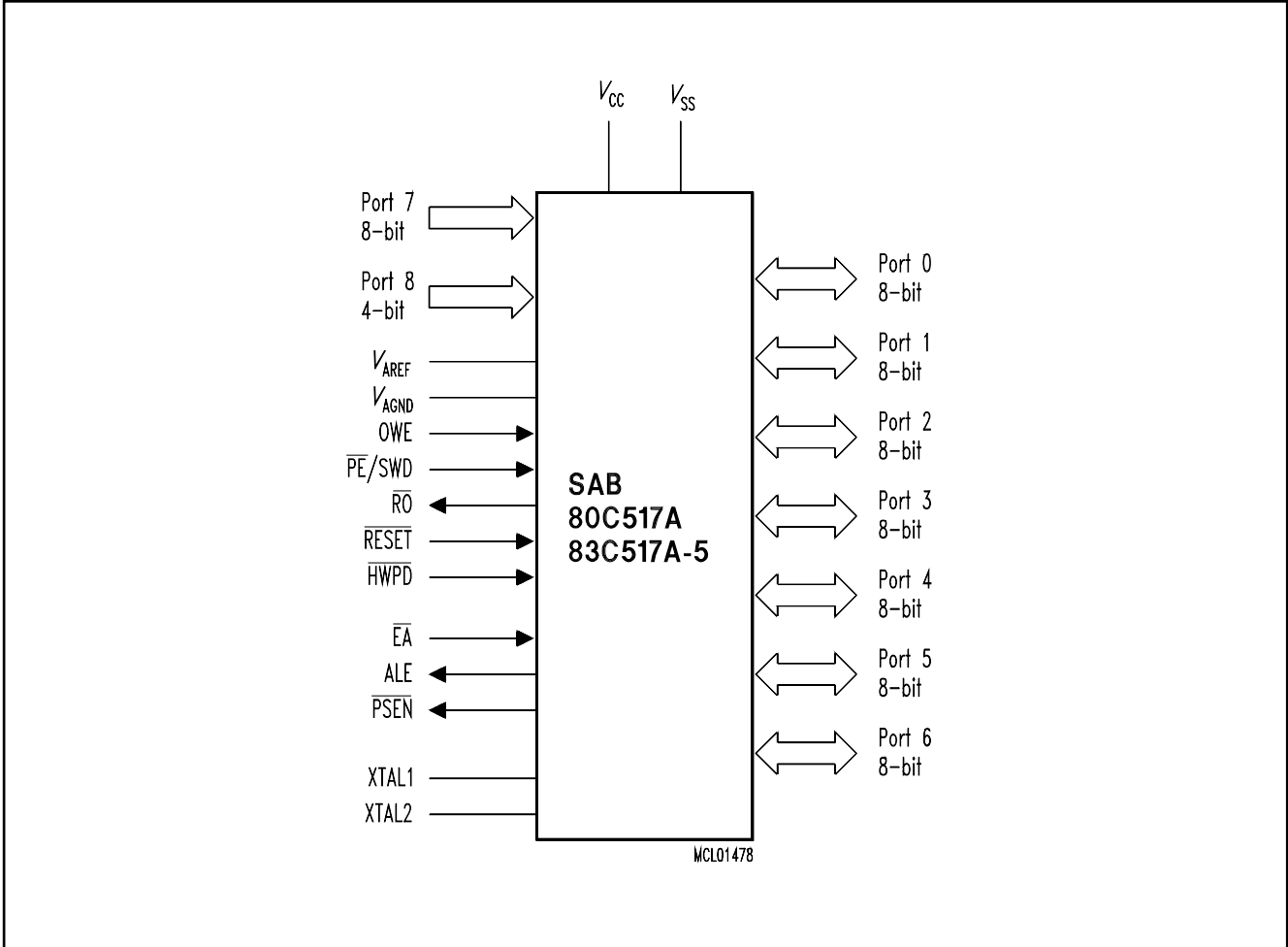
While maintaining all the SAB 80C517 features and operating characteristics the SAB 80C517A is expanded in its "fail-safe" characteristics and timer capabilities. The SAB 80C517A is identical with the SAB 83C517A-5 except that it lacks the on-chip program memory. The SAB 80C517A/83C517A-5 is supplied in a 84-pin plastic leaded chip carrier package (P-LCC-84) and in a 100-pin plastic quad flat package (P-MQFP-100-2).

SAB 80C517A/83C517A-5	
Revision History	05.94
Previous Releases	01.94/08.93/11.92/10.91/04.91
Page	Subjects (changes since last revision 04.91)
6	– Pin configuration P-MQFP-100-2 added
4	– Pin differences updated
7-15	– Pin numbers for P-MQFP-100-2 package added
several	– Correction of P-MRFP-100 into P-MQFP-100-2
3	– Ordering information for -40 to +110°C versions
26, 27, 31	– Correction of register names S0RELL, SCON, ADCON, ICRON, and SBUF
34	– Figure 4 corrected
41	– Figure 8 corrected
49	– \overline{PE}/SWD function description completed
60	– Correct ordering numbers
62	– Test condition for V_{OH} , V_{OH1} corrected
65	– t_{PXIZ} name corrected
	t_{AVIV} , t_{AZPL} values corrected
several	– Minimum clock frequency is now 3.5 MHz
66	– t_{QVWH} (data setup before \overline{WR}) corrected and added
66	– t_{LLAX2} corrected
Page	Subjects (changes since last revision 08.93)
26	– Corrected SFR name S0RELL
51	– Below "Termination of HWPD Mode": 4th paragraph with ident corrected
65	– Description of t_{LLIV} corrected
65	– Program Memory Read Cycle: t_{PXAV} added
74	– Oscillator circuit drawings: MQFP-100-2 pin numbers added.
Page	Subjects (changes since last revision 01.94)
47	– Minor changes on several pages
	– Table 6 corrected



Ordering Information

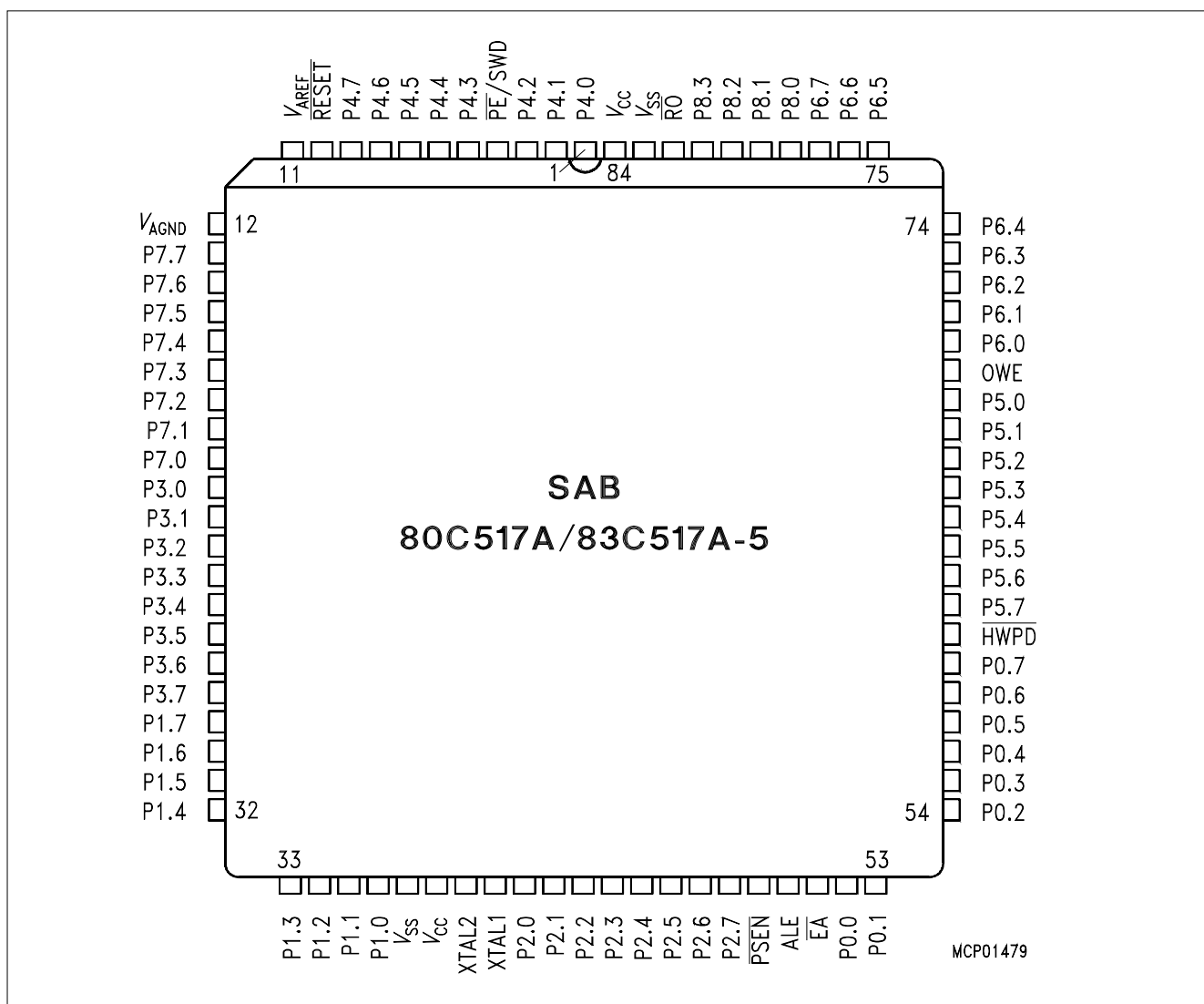
Type	Ordering Code	Package	Description 8-bit CMOS Microcontroller
SAB 80C517A-N18	Q67120-C583	P-LCC-84	for external memory, 18 MHz
SAB 80C517A-M18	TBD	P-MQFP-100-2	
SAB 83C517A-5N18	Q67120-C582	P-LCC-84	with mask-programmable ROM, 18 MHz
SAB 80C517A-N18-T3	Q67120-C769	P-LCC-84	for external memory, 18 MHz ext. temperature – 40 to 85 °C
SAB 83C517A-5N18-T3	Q67120-C771	P-LCC-84	with mask-programmable ROM, 18 MHz ext. temperature – 40 to 85 °C
SAB 83C517A-N18-T4	TBD	P-LCC-84	for external memory, 18 MHz ext. temperature -40 to +110°C
SAB 83C517A-5N18-T4	TBD	P-LCC-84	with mask-programmable ROM, 18 MHz ext. temperature -40 to +110°C



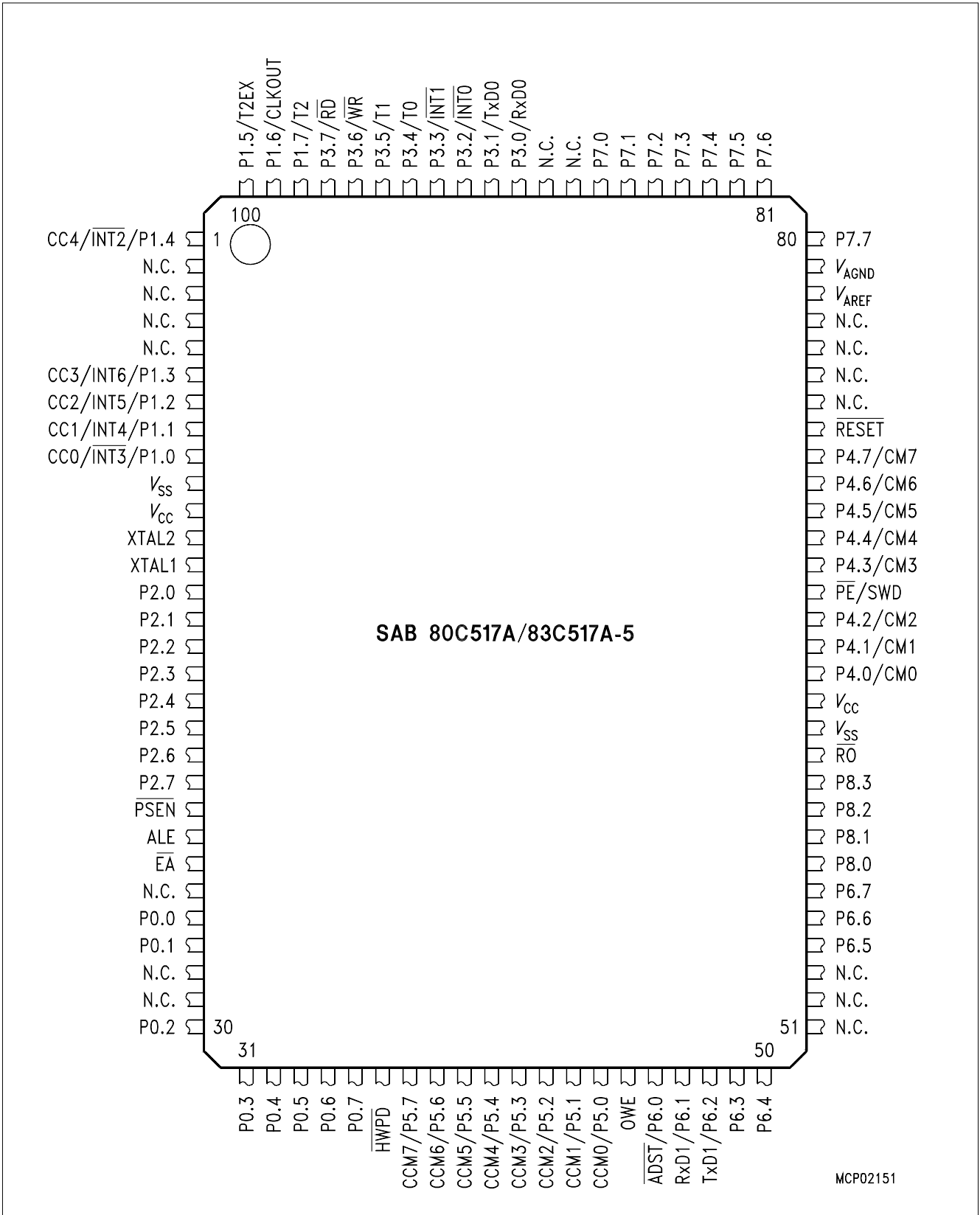
Logic Symbol

The pin functions of the SAB 80C517A are identical with those of the SAB 80C517/80C537 with one exception:

Typ	SAB 80C517A	SAB 80C517/80C537
P-LCC-84, Pin 60	HWRPD	N.C.
P-MQFP-100-2, Pin 36		



Pin Configuration (P-LCC-84)



MCP02151

Pin Configuration
(P-MQFP-100-2)

Pin Definitions and Functions

Symbol	Pin Number		I/O *)	Function
	P-LCC-84	P-MQFP-100-2		
P4.0 – P4.7	1– 3, 5 – 9	64 - 66, 68 - 72	I/O	<p>Port 4 is a bidirectional I/O port with internal pull-up resistors. Port 4 pins that have 1 s written to them are pulled high by the internal pull-up resistors, and in that state can be used as inputs. As inputs, port 4 pins being externally pulled low will source current (I_{IL}, in the DC characteristics) because of the internal pull-up resistors.</p> <p>This port also serves alternate compare functions. The secondary functions are assigned to the pins of port 4 as follows:</p> <ul style="list-style-type: none"> – CM0 (P4.0): Compare Channel 0 – CM1 (P4.1): Compare Channel 1 – CM2 (P4.2): Compare Channel 2 – CM3 (P4.3): Compare Channel 3 – CM4 (P4.4): Compare Channel 4 – CM5 (P4.5): Compare Channel 5 – CM6 (P4.6): Compare Channel 6 – CM7 (P4.7): Compare Channel 7
\overline{PE}/SWD	4	67	I	<p>Power saving modes enable Start Watchdog Timer</p> <p>A low level on this pin allows the software to enter the power down, idle and slow down mode. In case the low level is also seen during reset, the watchdog timer function is off on default.</p> <p>Use of the software controlled power saving modes is blocked, when this pin is held on high level. A high level during reset performs an automatic start of the watchdog timer immediately after reset. When left unconnected this pin is pulled high by a weak internal pull-up resistor.</p>

* I = Input
O = Output

Pin Definitions and Functions (cont'd)

Symbol	Pin Number		I/O *)	Function
	P-LCC-84	P-MQFP-100-2		
$\overline{\text{RESET}}$	10	73	I	RESET A low level on this pin for the duration of one machine cycle while the oscillator is running resets the SAB 80C517A. A small internal pull-up resistor permits power-on reset using only a capacitor connected to V_{SS} .
V_{AREF}	11	78		Reference voltage for the A/D converter.
V_{AGND}	12	79		Reference ground for the A/D converter.
P7.7 -P7.0	13 - 20	80 - 87	I	Port 7 is an 8-bit unidirectional input port. Port pins can be used for digital input, if voltage levels meet the specified input high/low voltages, and for the lower 8-bit of the multiplexed analog inputs of the A/D converter, simultaneously.

* I = Input
O = Output

Pin Definitions and Functions (cont'd)

Symbol	Pin Number		I/O *)	Function
	P-LCC-84	P-MQFP-100-2		
P3.0 - P3.7	21 - 28	90 - 97	I/O	<p>Port 3 is a bidirectional I/O port with internal pull-up resistors. Port 3 pins that have 1 s written to them are pulled high by the internal pull-up resistors, and in that state can be used as inputs. As inputs, port 3 pins being externally pulled low will source current (I_{IL}, in the DC characteristics) because of the internal pull-up resistors. Port 3 also contains the interrupt, timer, serial port 0 and external memory strobe pins that are used by various options. The output latch corresponding to a secondary function must be programmed to a one (1) for that function to operate.</p> <p>The secondary functions are assigned to the pins of port 3, as follows:</p> <ul style="list-style-type: none"> – R × D0 (P3.0): receiver data input (asynchronous) or data input/output (synchronous) of serial interface – T × D0 (P3.1): transmitter data output (asynchronous) or clock output (synchronous) of serial interface 0 – $\overline{INT0}$ (P3.2): $\overline{\text{interrupt 0 input/timer 0 gate control}}$ – $\overline{INT1}$ (P3.3): $\overline{\text{interrupt 1 input/timer 1 gate control}}$ – T0 (P3.4): counter 0 input – T1 (P3.5): counter 1 input – \overline{WR} (P3.6): the write control signal latches the data byte from port 0 into the external data memory – \overline{RD} (P3.7): the read control signal enables the external data memory to port 0

* I = Input
O = Output

Pin Definitions and Functions (cont'd)

Symbol	Pin Number		I/O *)	Function
	P-LCC-84	P-MQFP-100-2		
P1.7 - P1.0	29 - 36	98 - 100, 1, 6 - 9	I/O	<p>Port 1 is a bidirectional I/O port with internal pull-up resistors. Port 1 pins that have 1 s written to them are pulled high by the internal pull-up resistors, and in that state can be used as inputs. As inputs, port 1 pins being externally pulled low will source current (I_{IL}, in the DC characteristics) because of the internal pull-up resistors. It is used for the low order address byte during program verification. It also contains the interrupt, timer, clock, capture and compare pins that are used by various options. The output latch must be programmed to a one (1) for that function to operate (except when used for the compare functions).</p> <p>The secondary functions are assigned to the port 1 pins as follows:</p> <ul style="list-style-type: none"> – $\overline{\text{INT3}}/\text{CC0}$ (P1.0): $\overline{\text{interrupt 3 input}}$ / compare 0 output /capture 0 input – $\text{INT4}/\text{CC1}$ (P1.1): interrupt 4 input / compare 1 output /capture 1 input – $\text{INT5}/\text{CC2}$ (P1.2): interrupt 5 input / compare 2 output /capture 2 input – $\text{INT6}/\text{CC3}$ (P1.3): interrupt 6 input / compare 3 output /capture 3 input – $\overline{\text{INT2}}/\text{CC4}$ (P1.4): $\overline{\text{interrupt 2 input}}$ / compare 4 output /capture 4 input – T2EX (P1.5): timer 2 external reload trigger input – CLKOUT (P1.6): system clock output – T2 (P1.7): counter 2 input

* I = Input
O = Output

Pin Definitions and Functions (cont'd)

Symbol	Pin Number		I/O *)	Function
	P-LCC-84	P-MQFP-100-2		
XTAL2	39	12	–	XTAL2 Input to the inverting oscillator amplifier and input to the internal clock generator circuits.
XTAL1	40	13	–	XTAL1 Output of the inverting oscillator amplifier. To drive the device from an external clock source, XTAL2 should be driven, while XTAL1 is left unconnected. There are no requirements on the duty cycle of the external clock signal, since the input to the internal clocking circuitry is divided down by a divide-by-two flip-flop. Minimum and maximum high and low times as well as rise/fall times specified in the AC characteristics must be observed.
P2.0 - P2.7	41 - 48	14 - 21	I/O	Port 2 is a bidirectional I/O port with internal pull-up resistors. Port 2 pins that have 1 s written to them are pulled high by the internal pull-up resistors, and in that state can be used as in-puts. As inputs, port 2 pins being externally pulled low will source current (I_{IL} , in the DC characteristics) because of the internal pull-up resistors. Port 2 emits the high-order address byte during fetches from external program memory and during accesses to external data memory that use 16-bit addresses (MOVX @DPTR). In this application it uses strong internal pull-up resistors when issuing1 s. During accesses to external data memory that use 8-bit addresses (MOVX @Ri), port 2 issues the contents of the P2 special function register.

* I = Input
O = Output

Pin Definitions and Functions (cont'd)

Symbol	Pin Number		I/O *)	Function
	P-LCC-84	P-MQFP-100-2		
$\overline{\text{PSEN}}$	49	22	O	The Program Store Enable output is a control signal that enables the external program memory to the bus during external fetch operations. It is activated every six oscillator periods except during external data memory accesses. Remains high during internal program execution.
ALE	50	23	O	The Address Latch Enable output is used for latching the address into external memory during normal operation. It is activated every six oscillator periods except during an external data memory access
$\overline{\text{EA}}$	51	24	I	External Access Enable When held at high level, instructions are fetched from the internal ROM (SAB 83C517A-5 only) when the PC is less than 8000H. When held at low level, the SAB 80C517A fetches all instructions from external program memory. For the SAB 80C517A this pin must be tied low
P0.0 - P0.7	52 - 59	26 - 27, 30 - 35	I/O	Port 0 is an 8-bit open-drain bidirectional I/O port. Port 0 pins that have 1 s written to them float, and in that state can be used as high-impedance inputs. Port 0 is also the multiplexed low-order address and data bus during accesses to external program or data memory. In this application it uses strong internal pull-up resistors when issuing 1 s. Port 0 also out-puts the code bytes during program verification in the SAB 83C517A if ROM-Protection was not enabled. External pull-up resistors are required during program verification.

* I = Input
O = Output

Pin Definitions and Functions (cont'd)

Symbol	Pin Number		I/O *)	Function
	P-LCC-84	P-MQFP-100-2		
P6.0 - P6.7	70 - 77	46 - 50, 54 - 56	I/O	<p>Port 6 is a bidirectional I/O port with internal pull-up resistors. Port 6 pins that have 1 s written to them are pulled high by the internal pull-up resistors, and in that state can be used as inputs. As inputs, port 6 pins being externally pulled low will source current (I_{IL}, in the DC characteristics) because of the internal pull-up resistors. Port 6 also contains the external A/D converter control pin and the transmit and receive pins for serial channel 1. The output latch corresponding to a secondary function must be programmed to a one (1) for that function to operate. The secondary functions are assigned to the pins of port 6, as follows:</p> <ul style="list-style-type: none"> – \overline{ADST} (P6.0): external A/D converter start pin – $R \times D1$ (P6.1): receiver data input of serial interface 1 – $T \times D1$ (P6.2): transmitter data output of serial interface 1
P8.0 - P8.3	78 - 81	57 - 60	I	<p>Port 8 is a 4-bit unidirectional input port. Port pins can be used for digital input, if voltage levels meet the specified input high/low voltages, and for the higher 4-bit of the multiplexed analog inputs of the A/D converter, simultaneously</p>

* I = Input
O = Output

Pin Definitions and Functions (cont'd)

Symbol	Pin Number		I/O *)	Function
	P-LCC-84	P-MQFP-100-2		
\overline{RO}	82	61	O	Reset Output This pin outputs the internally synchronized reset request signal. This signal may be generated by an external hardware reset, a watchdog timer reset or an oscillator watch-dog reset. The reset output is active low.
V_{SS}	37, 83	10, 62	–	Circuit ground potential
V_{CC}	38, 84	11, 63	–	Supply Terminal for all operating modes
N.C.	–	2 - 5, 25, 28 - 29, 51 - 53, 74 - 77, 88 - 89	–	Not connected

* I = Input
O = Output

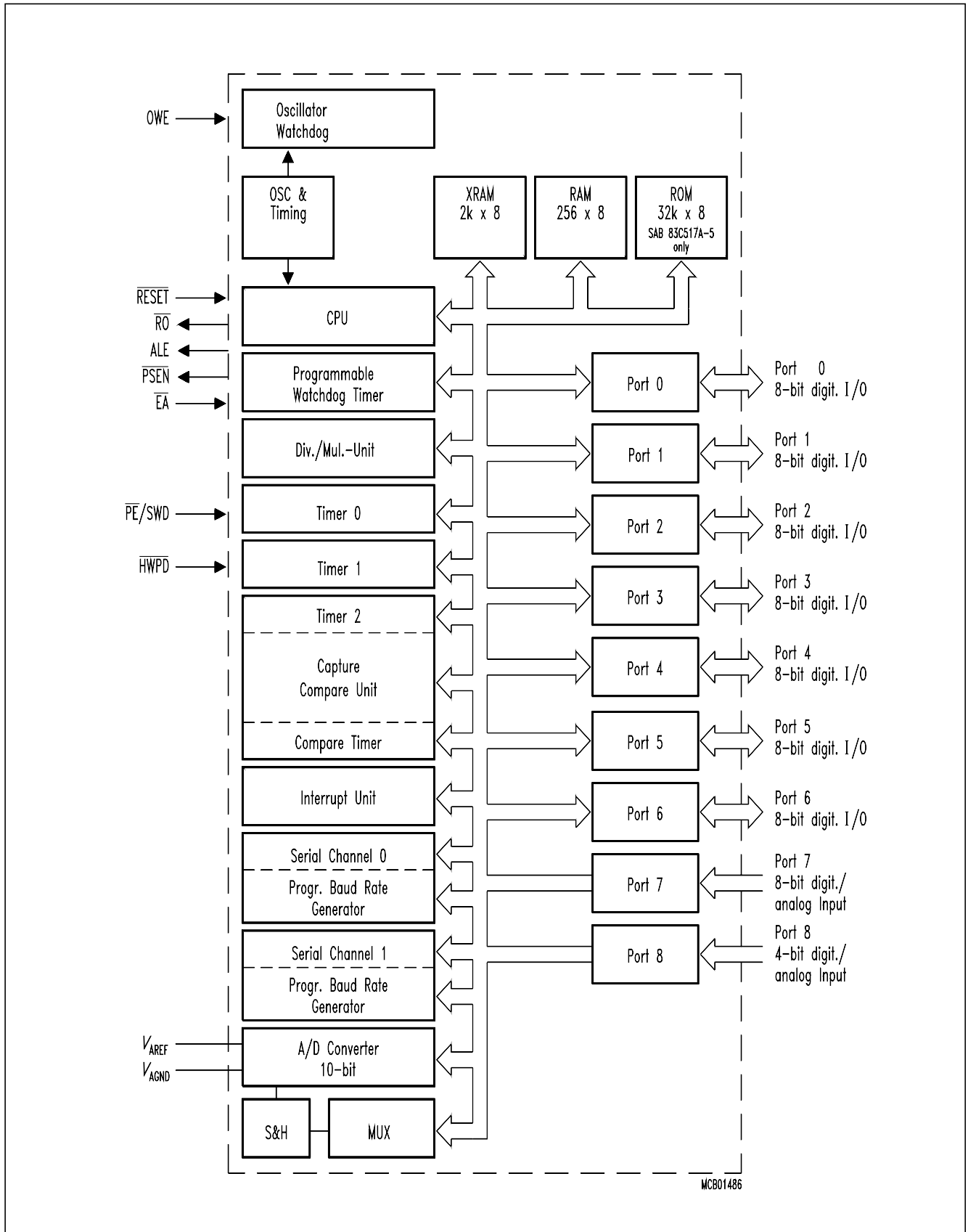


Figure 1
Block Diagram

Functional Description

The SAB 80C517A is based on 8051 architecture. It is a fully compatible member of the Siemens SAB 8051/80C51 microcontroller family being an significantly enhanced SAB 80C517. The SAB 80C517A is therefore compatible with code written for the SAB 80C517.

Having an 8-bit CPU with extensive facilities for bit-handling and binary BCD arithmetics the SAB 80C517A is optimized for control applications. With a 18 MHz crystal, 58 % of the instructions are executed in 666.67 ns.

Being designed to close the performance gap to the 16-bit microcontroller world, the SAB 80C517A's CPU is supported by a powerful 32-/16-bit arithmetic unit and a more flexible addressing of external memory by eight 16-bit datapointers.

Memory Organisation

According to the SAB 8051 architecture, the SAB 80C517A has separate address spaces for program and data memory. Figure 2 illustrates the mapping of address spaces.

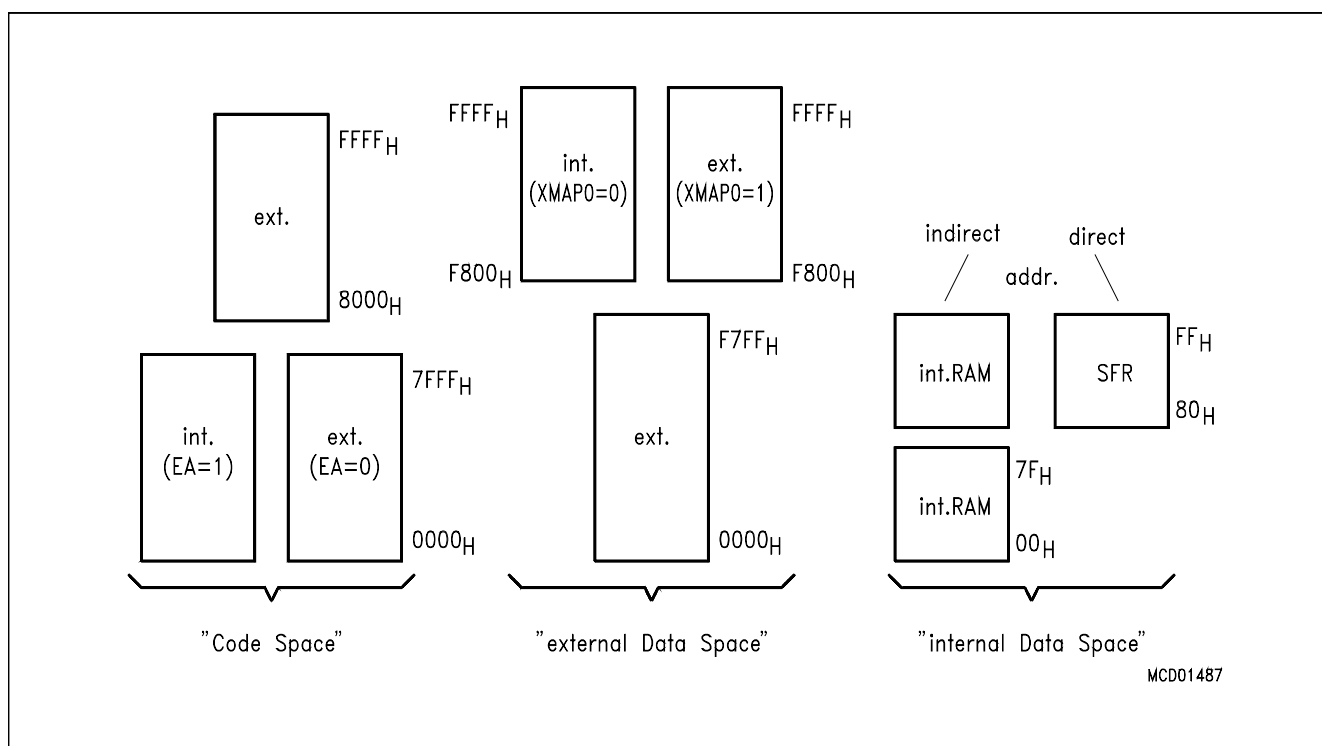


Figure 2
Memory Map

Program Memory ('Code Space')

The SAB 83C517A-5 has 32 Kbyte of on-chip ROM, while the SAB 80C517A has no internal ROM. The program memory can externally be expanded up to 64 Kbyte. Pin \overline{EA} controls whether program fetches below address 8000H are done from internal or external memory.

As a new feature the SAB 83C517A-5 offers the possibility of protecting the internal ROM against unauthorized access. This protection is implemented in the ROM-Mask. Therefore, the decision ROM-Protection 'yes' or 'no' has to be made when delivering the ROM-Code. Once enabled, there is no way of disabling the ROM-Protection.

Effect: The access to internal ROM done by an externally fetched MOVC instruction is disabled. Nevertheless, an access from internal ROM to external ROM is possible.

To verify the read protected ROM-Code a special ROM-Verify-Mode is implemented. This mode also can be used to verify unprotected internal ROM.

ROM -Protection	ROM-Verification Mode (see 'AC Characteristics')	Restrictions
no	ROM-Verification Mode 1 (standard 8051 Verification Mode) ROM-Verification Mode 2	–
yes	ROM-Verification Mode 2	– standard 8051 Verification Mode is disabled – externally applied MOVC accessing internal ROM is disabled

Data Memory ('Code Space')

The data memory space consists of an internal and an external memory space. The SAB 80C517A contains another 2 Kbyte on On-Chip RAM above the 256-bytes internal RAM of the base type SAB 80C517. This RAM is called XRAM in this document.

External Data Memory

Up to 64 Kbyte external data memory can be addressed by instructions that use 8-bit or 16-bit indirect addressing. For 8-bit addressing MOVX instructions in combination with registers R0 and R1 can be used. A 16-bit external memory addressing is supported by eight 16-bit datapointers. Registers XPAGE and SYSCON are controlling whether data fetches at addresses F800_H to FFFF_H are done from internal XRAM or from external data memory.

Internal Data Memory

The internal data memory is divided into four physically distinct blocks:

- the lower 128 bytes of RAM including four banks containing eight registers each
- the upper 128 byte of RAM
- the 128 byte special function register area.
- a 2 K × 8 area which is accessed like external RAM (MOVX-instructions), implemented on chip at the address range from F800_H to FFFF_H. Special Function Register SYSCON controls whether data is read or written to XRAM or external RAM.

A mapping of the internal data memory is also shown in figure 2. The overlapping address spaces are accessed by different addressing modes (see User's Manual SAB 80C517). The stack can be located anywhere in the internal data memory.

Architecture for the XRAM

The contents of the XRAM is not affected by a reset or HW Power Down. After power-up the contents is undefined, while it remains unchanged during and after a reset or HW Power Down if the power supply is not turned off.

The additional On-Chip RAM is logically located in the "external data memory" range at the upper end of the 64 Kbyte address range (F800_H-FFFF_H). It is possible to enable and disable (only by reset) the XRAM. If it is disabled the device shows the same behaviour as the parts without XRAM, i.e. all MOVX accesses use the external bus to physically external data memory.

Accesses to XRAM

Because the XRAM is used in the same way as external data memory the same instruction types must be used for accessing the XRAM.

Note: *If a reset occurs during a write operation to XRAM, the effect on XRAM depends on the cycle which the reset is detected at (MOVX is a 2-cycle instruction):*

Reset detection at cycle 1: The new value will not be written to XRAM. The old value is not affected.

Reset detection at cycle 2: The old value in XRAM is overwritten by the new value.

Accesses to XRAM using the DPTR

There are a Read and a Write instruction from and to XRAM which use one of the 16-bit DPTR for indirect addressing. The instructions are:

MOVX A, @DPTR (Read)

MOVX @DPTR, A (Write)

Normally the use of these instructions would use a physically external memory. However, in the SAB 80C517A the XRAM is accessed if it is enabled and if the DPTR points to the XRAM address space ($DPTR \geq F800_H$).

Accesses to XRAM using the Registers R0/R1

The 8051 architecture provides also instructions for accesses to external data memory range which use only an 8-bit address (indirect addressing with registers R0 or R1). The instructions are:

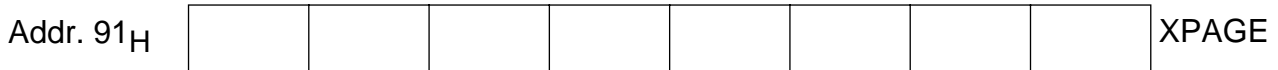
MOVX A, @Ri (Read)

MOVX @Ri, A (Write)

In application systems, either a real 8-bit bus (with 8-bit address) is used or Port 2 serves as page register which selects pages of 256-byte. However, the distinction, whether Port 2 is used as general purpose I/O or as "page address" is made by the external system design. From the device's point of view it cannot be decided whether the Port 2 data is used externally as address or as I/O data!

Hence, a special page register is implemented into the SAB 80C517A to provide the possibility of accessing the XRAM also with the MOVX @Ri instructions, i.e. XPAGE serves the same function for the XRAM as Port 2 for external data memory.

Special Function Register XPAGE



The reset value of XPAGE is 00_H.
 XPAGE can be set and read by software.

The register XPAGE provides the upper address byte for accesses to XRAM with MOVX @Ri instructions. If the address formed from XPAGE and Ri is less than the XRAM address range, then an external access is performed. For the SAB 80C517A the contents of XPAGE must be greater or equal than F8H in order to use the XRAM. Of course, the XRAM must be enabled if it shall be used with MOVX @Ri instructions.

Thus, the register XPAGE is used for addressing of the XRAM; additionally its contents are used for generating the internal XRAM select. If the contents of XPAGE is less than the XRAM address range then an external bus access is performed where the upper address byte is provided by P2 and not by XPAGE!

Therefore, the software has to distinguish two cases, if the MOVX @Ri instructions with paging shall be used:

- a) Access to XRAM: The upper address byte must be written to XPAGE or P2; both writes selects the XRAM address range.
- b) Access to external memory: The upper address byte must be written to P2; XPAGE will be loaded with the same address in order to deselect the XRAM.

Control of XRAM in the SAB 80C517A

There are two control bits in register SYSCON which control the use and the bus operation during accesses to the additional On-Chip RAM (XRAM).

Special Function Register SYSCON

Addr. 0B1 _H	—	—	—	—	—	—	XMAP1	XMAP0	SYSCON
------------------------	---	---	---	---	---	---	-------	-------	--------

Bit	Function
XMAP0	Global enable/disable bit for XRAM memory. XMAP0 = 0: The access to XRAM (= On-Chip XDATA memory) is enabled. XMAP0 = 1: The access to XRAM is disabled. All MOVX accesses are performed by the external bus (reset state).
XMAP1	Control bit for $\overline{RD}/\overline{WR}$ signals during accesses to XRAM; this bit has no effect if XRAM is disabled (XMAP0 = 1) or if addresses exceeding the XRAM address range are used for MOVX accesses. XMAP1 = 0: The signals \overline{RD} and \overline{WR} are not activated during accesses to XRAM. XMAP1 = 1: The signals \overline{RD} and \overline{WR} are activated during accesses to XRAM.

Reset value of SYSCON is xxxx xx01B.

The control bit XMAP0 is a global enable/disable bit for the additional On-Chip RAM (XRAM). If this bit is set, the XRAM is disabled, all MOVX accesses use external memory via the external bus. In this case the SAB 80C517A does not use the additional On-Chip RAM and is compatible with the types without XRAM.

XMAP0 is hardware protected by an unsymmetric latch. An unintentional disabling of XRAM could be dangerous since indeterminate values would be read from external bus. To avoid this the XMAP-bit is forced to '1' only by reset. Additionally, during reset an internal capacitor is loaded. So after reset state XRAM is disabled. Because of the load time of the capacitor XMAP0-bit once written to '0' (that is, discharging capacitor) cannot be set to '1' again by software. On the other hand any distortion (software hang up, noise, ...) is not able to load this capacitor, too. That is, the stable status is XRAM enabled. The only way to disable XRAM after it was enabled is a reset.

The clear instruction for XMAP0 should be integrated in the program initialization routine before XRAM is used. In extremely noisy systems the user may have redundant clear instructions.

The control bit XMAP1 is relevant only if the XRAM is accessed. In this case the external \overline{RD} and \overline{WR} signals at P3.6 and P3.7 are not activated during the access, if XMAP1 is cleared. For debug purposes it might be useful to have these signals and the addresses at Ports 0.2 available. This is performed if XMAP1 is set.

The behaviour of Port 0 and P2 during a MOVX access depends on the control bits in register SYSCON and on the state of pin \overline{EA} . The table 1 lists the various operating conditions. It shows the following characteristics:

a) Use of P0 and P2 pins during the MOVX access.

Bus: The pins work as external address/data bus. If (internal) XRAM is accessed, the data written to the XRAM can be seen on the bus in debug mode.

I/O: The pins work as Input/Output lines under control of their latch.

b) Activation of the \overline{RD} and \overline{WR} pin during the access.

c) Use of internal or external XDATA memory.

The shaded areas describe the standard operation as each 80C51 device without on-chip XRAM behaves.

Table 1:
Behaviour of P0/P2 and $\overline{RD}/\overline{WR}$ during MOVX accesses

		$\overline{EA} = 0$			$\overline{EA} = 1$		
		XMAP1, XMAP0			XMAP1, XMAP0		
		00	10	X1	00	10	X1
MOVX @DPTR	DPTR < XRAM address range	a) P0/P2→Bus b) $\overline{RD}/\overline{WR}$ active c) ext. memory is used	a) P0/P2→Bus b) $\overline{RD}/\overline{WR}$ active c) ext. memory is used	a) P0/P2→Bus b) $\overline{RD}/\overline{WR}$ active c) ext. memory is used	a) P0/P2→Bus b) $\overline{RD}/\overline{WR}$ active c) ext. memory is used	a) P0/P2→Bus b) $\overline{RD}/\overline{WR}$ active c) ext. memory is used	a) P0/P2→Bus b) $\overline{RD}/\overline{WR}$ active c) ext. memory is used
	DPTR ≥ XRAM address range	a) P0/P2→BUS (\overline{WR} -Data only) b) $\overline{RD}/\overline{WR}$ inactive c) XRAM is used	a) P0/P2→BUS (\overline{WR} -Data only) b) $\overline{RD}/\overline{WR}$ active c) XRAM is used	a) P0/P2→Bus b) $\overline{RD}/\overline{WR}$ active c) ext. memory is used	a) P0/P2→I/O b) $\overline{RD}/\overline{WR}$ inactive c) XRAM is used	a) P0/P2→BUS (\overline{WR} -Data only) b) $\overline{RD}/\overline{WR}$ active c) XRAM is used	a) P0/P2→Bus b) $\overline{RD}/\overline{WR}$ active c) ext. memory is used
MOVX @Ri	XPAGE < XRAM addr. page range	a) P0→Bus P2→I/O b) $\overline{RD}/\overline{WR}$ active c) ext. memory is used	a) P0→Bus P2→I/O b) $\overline{RD}/\overline{WR}$ active c) ext. memory is used	a) P0→Bus P2→I/O b) $\overline{RD}/\overline{WR}$ active c) ext. memory is used	a) P0→Bus P2→I/O b) $\overline{RD}/\overline{WR}$ active c) ext. memory is used	a) P0→Bus P2→I/O b) $\overline{RD}/\overline{WR}$ active c) ext. memory is used	a) P0→Bus P2→I/O b) $\overline{RD}/\overline{WR}$ active c) ext. memory is used
	XPAGE ≥ XRAM addr. page range	a) P0/P2→BUS (\overline{WR} -Data only) P2→I/O b) $\overline{RD}/\overline{WR}$ inactive c) XRAM is used	a) P0/P2→BUS (\overline{WR} -Data only) P2→I/O b) $\overline{RD}/\overline{WR}$ active c) XRAM is used	a) P0→Bus P2→I/O b) $\overline{RD}/\overline{WR}$ active c) ext. memory is used	a) P0/P2→I/O b) $\overline{RD}/\overline{WR}$ inactive c) XRAM is used	a) P0→BUS (\overline{WR} -Data only) P2→I/O b) $\overline{RD}/\overline{WR}$ active c) XRAM is used	a) P0→Bus P2→I/O b) $\overline{RD}/\overline{WR}$ active c) ext. memory is used

modes compatible to 8051 - family

Multiple Datapointers

As a functional enhancement to standard 8051 controllers, the SAB 80C517A contains eight 16-bit datapointers. The instruction set uses just one of these datapointers at a time. The selection of the actual datapointer is done in special function register DPSEL (data pointer select, addr. 92_H). Figure 3 illustrates the addressing mechanism.

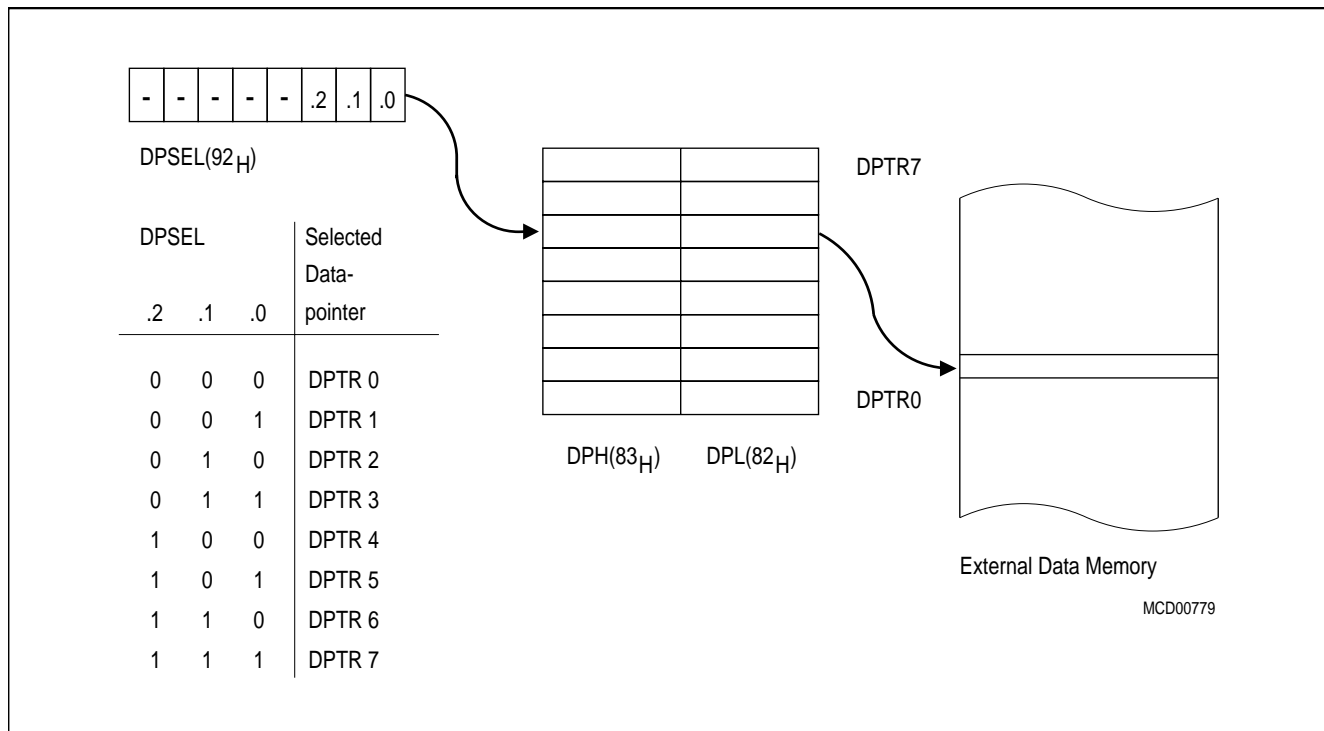


Figure 3
Addressing of External Data Memory

Special Function Registers

All registers, except the program counter and the four general purpose register banks, reside in the special function register area. The 81 special function registers include arithmetic registers, pointers, and registers that provide an interface between the CPU and the on-chip peripherals. There are also 128 directly addressable bits within the SFR area. All special function registers are listed in table 1 and table 2.

In table 1 they are organized in numeric order of their addresses. In table 2 they are organized in groups which refer to the functional blocks of the SAB 80C517A.

Table 2
Special Function Register

Address	Register	Contents after Reset	Address	Register	Contents after Reset
80_H	P0 ¹⁾	FF_H	98_H	S0CON ¹⁾	00_H
81 _H	SP	07 _H	99 _H	S0BUF	XX _H
82 _H	DPL	00 _H	9A _H	IEN2	XX00 00X0 _B
83 _H	DPH	00 _H	9B _H	S1CON	0X00 0000 _B
84 _H	(WDTL) ³⁾	(00 _H)	9C _H	S1BUF	XX _H
85 _H	(WDTH) ³⁾	(00 _H)	9D _H	S1RELL	00 _H
86 _H	WDTREL	00 _H	9E _H	reserved	XX _H
87 _H	PCON	00 _H	9F _H	reserved	XX _H
88_H	TCON ¹⁾	00_H	A0_H	P2 ¹⁾	FF_H
89 _H	TMOD	00 _H	A1 _H	COMSETL	00 _H
8A _H	TL0	00 _H	A2 _H	COMSETH	00 _H
8B _H	TL1	00 _H	A3 _H	COMCLRL	00 _H
8C _H	TH0	00 _H	A4 _H	COMCLRH	00 _H
8D _H	TH1	00 _H	A5 _H	SETMSK	00 _H
8E _H	reserved	XX _H ²⁾	A6 _H	CLRMSK	00 _H
8F _H	reserved	XX _H ²⁾	A7 _H	reserved	XX _H ²⁾
90_H	P1 ¹⁾	FF_H	A8_H	IEN0 ¹⁾	00_H
91 _H	XPAGE	00 _H	A9 _H	IP0	00 _H
92 _H	DPSEL	XXXXX000 _B	AA _H	S0RELL	D9 _H
93 _H	reserved	XX _H ²⁾	AB _H	reserved	XX _H ²⁾
94 _H	reserved	XX _H ²⁾	AC _H	reserved	XX _H ²⁾
95 _H	reserved	XX _H ²⁾	AD _H	reserved	XX _H ²⁾
96 _H	reserved	XX _H ²⁾	AE _H	reserved	XX _H ²⁾
97 _H	reserved	XX _H ²⁾	AF _H	reserved	XX _H ²⁾

¹⁾ Bit-addressable special function registers

²⁾ X means that the value is indeterminate and the location is reserved

³⁾ ()... SFRs not user accessible

Table 2
Special Function Register (cont'd)

Address	Register	Contents after Reset	Address	Register	Contents after Reset
B0_H B1 _H B2 _H B3 _H B4 _H B5 _H B6 _H B7 _H	P3 ¹⁾ SYSCON reserved reserved reserved reserved reserved reserved	FF_H XXXX XX01 _B XX _H ²⁾ XX _H ²⁾ XX _H ²⁾ XX _H ²⁾ XX _H ²⁾ XX _H ²⁾	D0_H D1 _H D2 _H D3 _H D4 _H D5 _H D6 _H D7 _H	PSW ¹⁾ IRCON1 CML0 CMH0 CML1 CMH1 CML2 CMH2	00_H 00 _H 00 _H 00 _H 00 _H 00 _H 00 _H 00 _H
B8_H B9 _H BA _H BB _H BC _H BD _H BS _H BF _H	IEN1 ¹⁾ IP1 S0RELH S1RELH reserved reserved reserved reserved	00_H XX00 0000 _B XXXX XX11 _B XXXX XX11 _B XX _H XX _H XX _H XX _H	D8_H D9 _H DA _H DB _H DC _H DD _H DE _H DF _H	ADCON0 ¹⁾ ADDATH ADDATL P7 ADCON1 P8 CTRELL CTRELH	00_H 00 _H 00 _H XX _H XXXX0000 _B XX _H 00 _H 00 _H
C0_H C1 _H C2 _H C3 _H C4 _H C5 _H C6 _H C7 _H	IRCON0 ¹⁾ CCEN CCL1 CCH1 CCL2 CCH2 CCL3 CCH3	00_H 00 _H 00 _H 00 _H 00 _H 00 _H 00 _H 00 _H	E0_H E1 _H E2 _H E3 _H E4 _H E5 _H E6 _H E7 _H	ACC ¹⁾ CTCON CML3 CMH3 CML4 CMH4 CML5 CMH5	00_H 0X00 0000 _B XX _H 00 _H 00 _H 00 _H 00 _H 00 _H
C8_H C9 _H CA _H CB _H CC _H CD _H CE _H CF _H	T2CON ¹⁾ CC4EN CRCL CRCH TL2 TH2 CCL4 CCH4	00_H 00 _H 00 _H 00 _H 00 _H 00 _H 00 _H 00 _H	E8_H E9 _H EA _H EB _H EC _H ED _H EE _H EF _H	P4 ¹⁾ MD0 MD1 MD2 MD3 MD4 MD5 ARCON	FF_H XX _H XX _H XX _H XX _H XX _H XX _H 0XXX XXXX _B

¹⁾ Bit-addressable special function registers

²⁾ X means that the value is indeterminate and the location is reserved

³⁾ (...) SFRs not user accessible

Table 2
Special Function Register (cont'd)

Address	Register	Contents after Reset	Address	Register	Contents after Reset
F0_H	B ¹⁾	00_H	F8_H	P5 ¹⁾	FF_H
F1 _H	reserved	XX _H	F9 _H	reserved	XX _H
F2 _H	CML6	00 _H	FA _H	P6	FF _H
F3 _H	CMH6	00 _H	FB _H	reserved	XX _H
F4 _H	CML7	00 _H	FC _H	reserved	XX _H
F5 _H	CMH7	00 _H	FD _H	(IS0)	XX _H
F6 _H	CMEN	00 _H	FE _H	(IS1)	XX _H
F7 _H	CMSEL	00 _H	FF _H	reserved	XX _H

1) Bit-addressable special function registers

2) X means that the value is indeterminate and the location is reserved

3) ()... SFRs not user accessible

Table 3
Special Function Registers - Functional Blocks

Block	Symbol	Name	Address	Contents after Reset
CPU	ACC	Accumulator	E0_H ¹⁾	00 _H
	B	B-Register	F0_H ¹⁾	00 _H
	DPH	Data Pointer, High Byte	83 _H	00 _H
	DPL	Data Pointer, Low Byte	82 _H	00 _H
	DPSEL	Data Pointer Select Register	92 _H	XXXX X000 _B ³⁾
	PSW	Program Status Word Register	D0_H ¹⁾	00 _H
	SP	Stack Pointer	81 _H	07 _H
A/D- Converter	ADCON0	A/D Converter Control Register 0	D8_H ¹⁾	00 _H
	ADCON1	A/D Converter Control Register 1	DC _H	00 _H
	ADDATH	A/D Converter Data Reg. High Byte	D9 _H	00 _H
	ADDATL	A/D Converter Data Reg. Low Byte	DA _H	00 _H
Interrupt System	IEN0	Interrupt Enable Register 0	A8_H ¹⁾	00_H
	CTCON ²⁾	Com. Timer Control Register	E1 _H	0XXX.0000 _B
	IEN1	Interrupt Enable Register 1	B8_H ¹⁾	00_H
	IEN2	Interrupt Enable Register 2	9A _H	XXXX.00X0 _B ³⁾
	IP0	Interrupt Priority Register 0	A9 _H	00 _H
	IP1	Interrupt Priority Register 1	B9 _H	XX00 0000 _B
	IRCON0	Interrupt Request Control Register	C0_H ¹⁾	00 _H
	IRCON1	Interrupt Request Control Register	D1 _H	00 _H
	TCON ²⁾	Timer Control Register	88_H ¹⁾	00 _H
	TCON ²⁾	Timer 2 Control Register	C8_H	00 _H
MUL/DIV Unit	ARCON	Arithmetic Control Register	EF _H	0XXXX XXXX _B
	MD0	Multiplication/Division Register 0	E9 _H	XX _H
	MD1	Multiplication/Division Register 1	EA _H	XX _H
	MD2	Multiplication/Division Register 2	EB _H	XX _H
	MD3	Multiplication/Division Register 3	EC _H	XX _H
	MD4	Multiplication/Division Register 4	ED _H	XX _H
	MD5	Multiplication/Division Register 5	EE _H	XX _H

¹⁾ Bit-addressable special function registers

²⁾ This special function register is listed repeatedly since some bits of it also belong to other functional blocks.

³⁾ X means that the value is indeterminate and the location is reserved

Table 3
Special Function Registers - Functional Blocks (cont'd)

Block	Symbol	Name	Address	Contents after Reset
Compare/ Capture- Unit (CCU) Timer 2	CCEN	Comp./Capture Enable Reg.	C1 _H	00 _H
	CC4EN	Comp./Capture Enable 4 Reg.	C9 _H	00 _H
	CCH1	Comp./Capture Reg. 1, High Byte	C3 _H	00 _H
	CCH2	Comp./Capture Reg. 2, High Byte	C5 _H	00 _H
	CCH3	Comp./Capture Reg. 3, High Byte	C7 _H	00 _H
	CCH4	Comp./Capture Reg. 4, High Byte	CF _H	00 _H
	CCL1	Comp./Capture Reg. 1, Low Byte	C2 _H	00 _H
	CCL2	Comp./Capture Reg. 2, Low Byte	C4 _H	00 _H
	CCL3	Comp./Capture Reg. 3, Low Byte	C6 _H	00 _H
	CCL4	Comp./Capture Reg. 4, Low Byte	CE _H	00 _H
	CMEN	Compare Enable Register	F6 _H	00 _H
	CMH0	Compare Register 0, High Byte	D3 _H	00 _H
	CMH1	Compare Register 1, High Byte	D5 _H	00 _H
	CMH2	Compare Register 2, High Byte	D7 _H	00 _H
	CMH3	Compare Register 3, High Byte	E3 _H	00 _H
	CMH4	Compare Register 4, High Byte	E5 _H	00 _H
	CMH5	Compare Register 5, High Byte	E7 _H	00 _H
	CMH6	Compare Register 6, High Byte	F3 _H	00 _H
	CMH7	Compare Register 7, High Byte	F5 _H	00 _H
	CML0	Compare Register 0, Low Byte	D2 _H	00 _H
	CML1	Compare Register 1, Low Byte	D4 _H	00 _H
	CML2	Compare Register 2, Low Byte	D6 _H	00 _H
	CML3	Compare Register 3, Low Byte	E2 _H	00 _H
	CML4	Compare Register 4, Low Byte	E4 _H	00 _H
	CML5	Compare Register 5, Low Byte	E6 _H	00 _H
	CML6	Compare Register 6, Low Byte	F2 _H	00 _H
	CML7	Compare Register 7, Low Byte	F4 _H	00 _H
	CMSEL	Compare Input Select	F7 _H	00 _H
	CRCH	Com./Rel./Capt. Reg. High Byte	CB _H	00 _H
	CRCL	Com./Rel./Capt. Reg. Low Byte	CA _H	00 _H
	COMSETL	Compare Register, Low Byte	A1 _H	00 _H
	COMSETH	Compare Register, High Byte	A2 _H	00 _H
	COMCLRL	Compare Register, Low Byte	A3 _H	00 _H
	COMCLRH	Compare Register, High Byte	A4 _H	00 _H
SETMSK	Mask Register, concerning COMSET	A5 _H	00 _H	

¹⁾ Bit-addressable special function registers

²⁾ This special function register is listed repeatedly since some bits of it also belong to other functional blocks.

³⁾ X means that the value is indeterminate and the location is reserved

Table 3
Special Function Registers - Functional Blocks (cont'd)

Block	Symbol	Name	Address	Contents after Reset
Compare/ Capture- Unit (CCU), (cont'd)	CLRMSK	Mask Register, concerning COMCLR	A6 _H	00 _H
	CTCON	Com. Timer Control Reg.	E1 _H	0X00 0000 _B ³⁾
	CTRELH	Com. Timer Rel. Reg., High Byte	DF _H	00 _H
	CTRELL	Com. Timer Rel. Reg., Low Byte	DE _H	00 _H
	TH2	Timer 2, High Byte	CD _H	00 _H
	TL2	Timer 2, Low Byte	CC _H	00 _H
	T2CON	Timer 2 Control Register	C8_H ¹⁾	00 _H
Ports	P0	Port 0	80_H ¹⁾	FF _H
	P1	Port 1	90_H ¹⁾	FF _H
	P2	Port 2	A0_H ¹⁾	FF _H
	P3	Port 3	B0_H ¹⁾	FF _H
	P4	Port 4	E8_H ¹⁾	FF _H
	P5	Port 5	F8_H ¹⁾	FF _H
	P6	Port 6,	FA _H	FF _H
	P7 P8	Port 7, Analog/Digital Input Port 8, Analog/Digital Input, 4-bit	DB _H DD _H	
Pow.Sav. Modes	PCON	Power Control Register	87 _H	00 _H
Serial Channels	ADCON0 ²⁾	A/D Converter Control Reg.	D8_H ¹⁾	00_H
	PCON ²⁾	Power Control Register	87 _H	00 _H
	S0BUF	Serial Channel 0 Buffer Reg.	99 _H	XX _H ³⁾
	S0CON	Serial Channel 0 Control Reg.	98_H ¹⁾	00_H
	S0RELL	Serial Channel 0, Reload Reg., low byte	B2 _H	0D9 _H
	S0RELH	Serial Channel 0, Reload Reg., high byte	BA _H	XXXX.XX11 _B ³⁾
	S1BUF	Serial Channel 1 Buffer Reg.,	9C _H	0XX _H ³⁾
	S1CON	Serial Channel 1 Control Reg.	9B _H	0X00.0000 _B ³⁾
	S1REL	Serial Channel 1 Reload Reg., low byte	9D _H	00 _H
S1RELH	Serial Channel 1 Reload Reg., high byte	BB _H	XXXX.XX11 _B ³⁾	

¹⁾ Bit-addressable special function registers

²⁾ This special function register is listed repeatedly since some bits of it also belong to other functional blocks.

³⁾ X means that the value is indeterminate and the location is reserved

Table 3
Special Function Registers - Functional Blocks (cont'd)

Block	Symbol	Name	Address	Contents after Reset
Timer 0/ Timer 1	TCON	Timer Control Register	88H ¹⁾	00 _H
	TH0	Timer 0, High Byte	8C _H	00 _H
	TH1	Timer 1, High Byte	8D _H	00 _H
	TL0	Timer 0, Low Byte	8A _H	00 _H
	TL1	Timer 1, Low Byte	8B _H	00 _H
	TMOD	Timer Mode Register	89 _H	00 _H
Watchdog	IEN0 ²⁾	Interrupt Enable Register 0	A8H ¹⁾	00 _H
	IEN1 ²⁾	Interrupt Enable Register 1	B8H ¹⁾	00 _H
	IP0 ²⁾	Interrupt Priority Register 0	A9 _H	00 _H
	IP1 ²⁾	Interrupt Priority Register 1	B9 _H	XX00 0000 _B ³⁾
	WDTREL	Watchdog Timer Reload Reg.	86 _H	00 _H

1) Bit-addressable special function registers

2) This special function register is listed repeatedly since some bits of it also belong to other functional blocks.

3) X means that the value is indeterminate and the location is reserved

A/D Converter

In the SAB 80C517A a new high performance / high-speed 12-channel 10-bit A/D-Converter is implemented. Its successive approximation technique provides $7\ \mu\text{s}$ conversion time ($f_{\text{OSC}} = 16\ \text{MHz}$). The conversion principle is upward compatible to the one used in the SAB 80C517. The main functional blocks are shown in figure 4.

The comparator is a fully differential comparator for a high power supply rejection ratio and very low offset voltages. The capacitor network is binary weighted providing genuine 10-bit resolution.

The table below shows the sample time T_S and the conversion time T_C , which are dependent on f_{OSC} and a new prescaler (see also Bit ADCL in SFR ADCON 1).

f_{OSC} [MHz]	Prescaler	f_{ADC} [MHz]	Sample Time T_S [μs]	Conversion Time (incl. sample time) T_C [μs]
12	$\div 8$	1.5	2.67	9.33
	$\div 16$	0.75	5.33	18.66
16	$\div 8$	2.0	2.0	7.0
	$\div 16$	1.0	4.0	14.0
18	$\div 8$	—	—	—
	$\div 16$	1.125	3.55	12.4

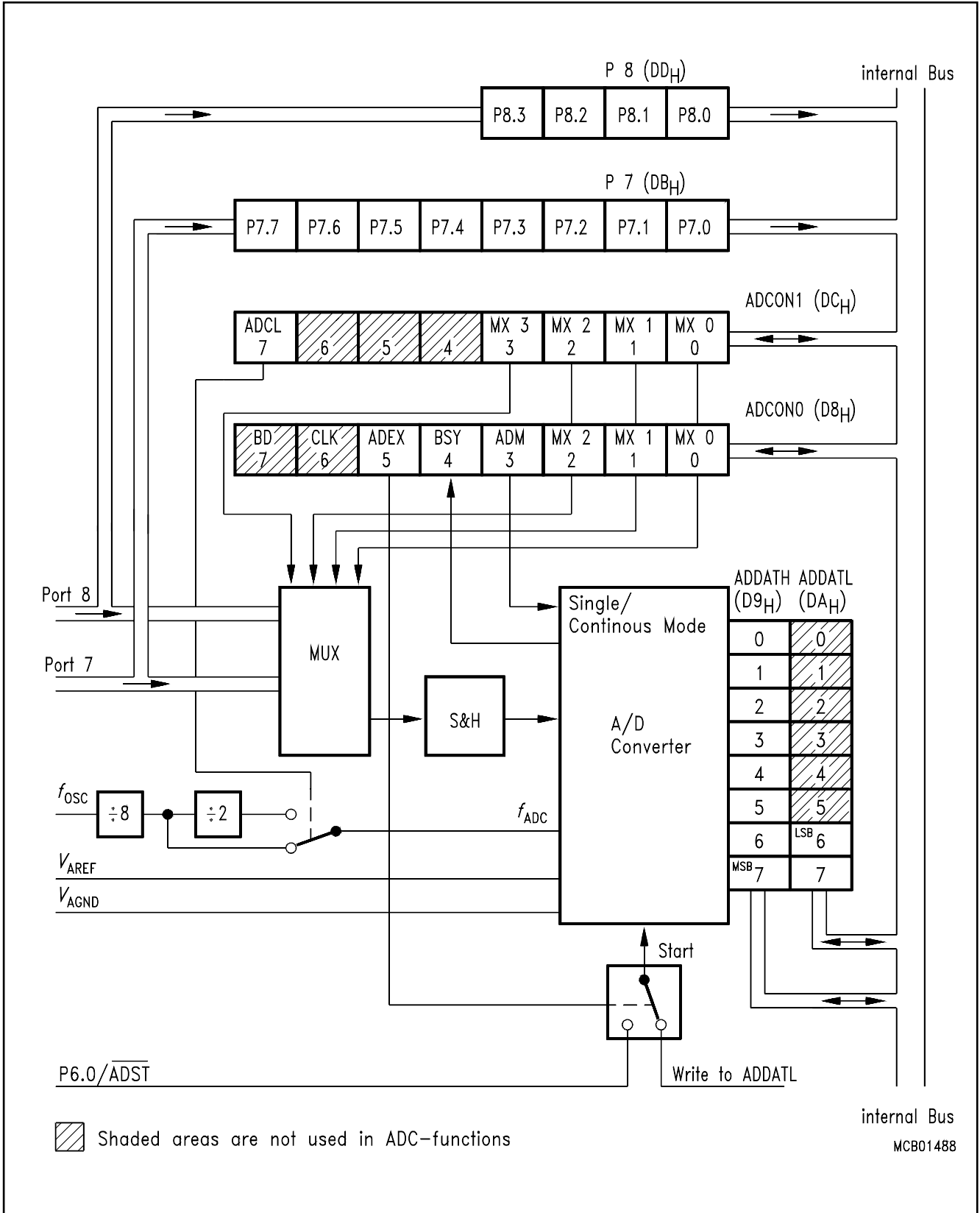


Figure 4
Block Diagram A/D Converter

Compare/Capture Unit (CCU)

The compare/capture unit is a complex timer/register array for applications that require high speed I/O pulse width modulation and more timer/counter capabilities.

The CCU contains

- one 16-bit timer/counter (**timer2**) with 2-bit prescaler, reload capability and a max. clock frequency of $f_{OSC}/12$ (1 MHz with a 12 MHz crystal).
- one 16-bit timer (**compare timer**) with 8-bit prescaler, reload capability and a max. clock frequency of $f_{OSC}/2$ (6 MHz with a 12 MHz crystal).
- fifteen 16-bit compare registers.
- five of which can be used as 16-bit capture registers.
- up to 21 output lines controlled by the CCU.
- nine interrupts which can be generated by CCU-events.

Figure 5 shows a block diagram of the CCU. Eight compare registers (CM0 to CM7) can individually be assigned to either timer 2 or the compare timer. Diagrams of the two timers are shown in figures 6 and 7. The four compare/capture registers, the compare/reload/capture register and the comset/comclr register are always connected to timer 2. Depending on the register type and the assigned timer three different compare modes can be selected.

Table 3 illustrates possible combinations and the corresponding output lines.

Table 4
CCU Compare Configuration

Assigned Timer	Compare Register	Compare Output	Possible Modes
Timer 2	CRCH/CRCL	P1.0/ $\overline{\text{INT3}}$ /CC0	Comp. mode 0, 1 + Reload
	CC1H/CC1L	P1.1/INT4/CC1	Comp. mode 0, 1
	CC2H/CC2L	P1.2/INT5/CC2	Comp. mode 0, 1
	CC3H/CC3L	P1.3/INT6/CC3	Comp. mode 0, 1
	CC4H/CC4L	P1.4/ $\overline{\text{INT2}}$ /CC4	Comp. mode 0, 1
	CC4H/CC4L	P5.0/CCM0	Comp. mode 1
	:	:	:
	CC4H/CC4L	P5.7/CCM7	Comp. mode 1
	COMSETL/COMSETH	P5.0/CCM0	Comp. mode 2
		:	:
		P5.7/CCM7	Comp. mode 2
	COMCLRL/ COMCLRH	P5.0/CCM0	Comp. mode 2
		:	:
		P5.7/CCM7	Comp. mode 2
CM0H/CM0L	P4.0/CM0	Comp. mode 1	
:	:	:	
CM7H/CM7L	P4.7/CM7	Comp. mode 1	
Compare timer	CM0H/CM0L	P4.0/CM0	Comp. mode 0 (with shadow latches)
	:	:	:
	CM7H/CM7L	P4.7/CM7	Comp. mode 0 (with shadow latches)

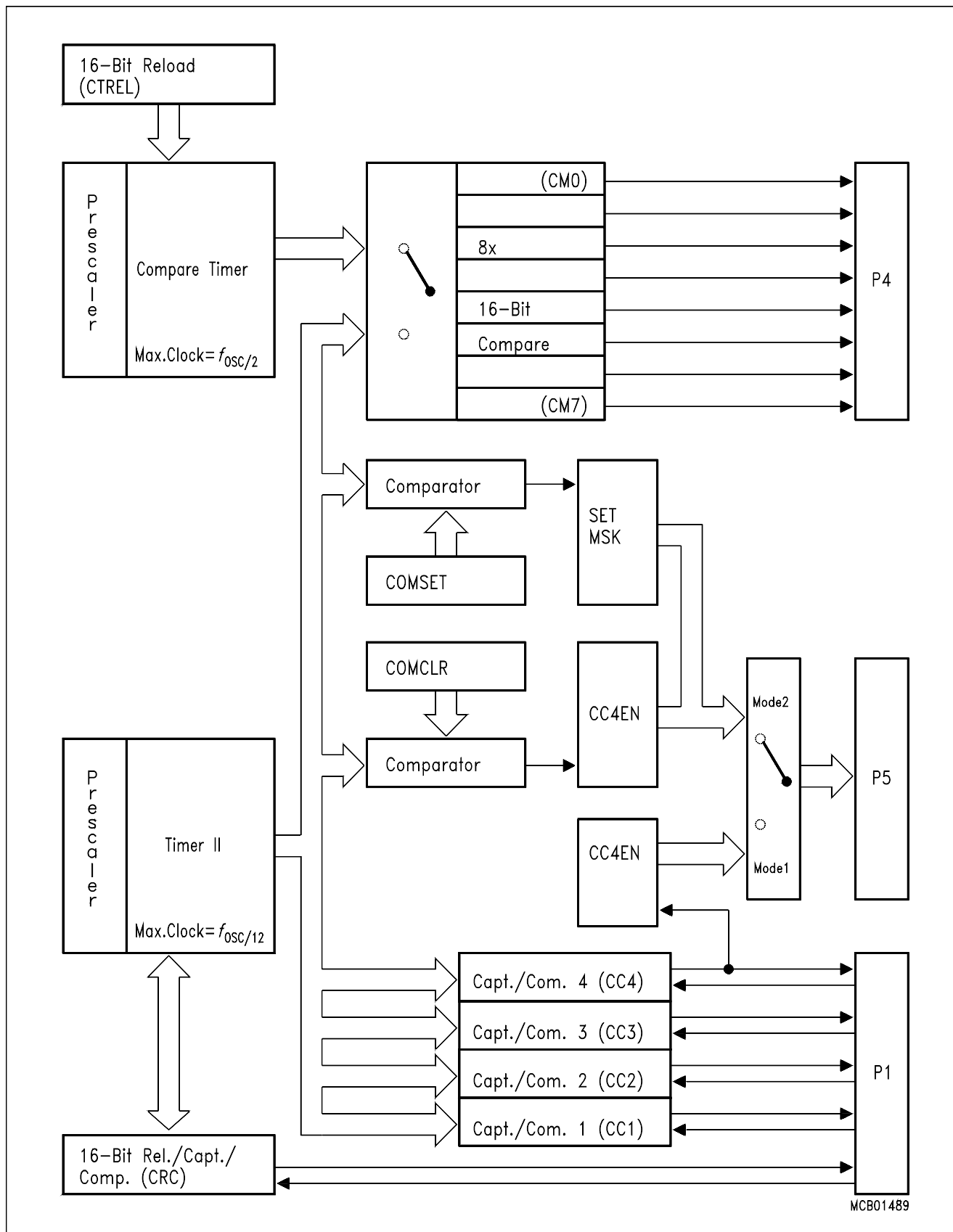


Figure 5
Block Diagram of the Compare/Capture Unit

Compare

In compare mode, the 16-bit values stored in the dedicated compare registers are compared to the contents of the timer 2 register or the compare timer register. If the count value in the timer registers matches one of the stored value, an appropriate output signal is generated at the corresponding pin(s) and an interrupt is requested. Three compare modes are provided:

- Mode 0: Upon a match the output signal changes from low to high. It returns to low level at timer overflow.
- Mode 1: The transition of the output signal can be determined by software. A timer overflow signal does not affect the compare-output.
- Mode 2: In compare mode 2 the concurrent compare output pins on Port 5 are used as follows (see figure 9)
- When a compare match occurs with register COMSET, a high level appears at the pins of port 5 whose corresponding bits in the mask register SETMSK (address 0A5H) are set.
 - When a compare match occurs in register COMCLR, a low level appears at the pins of port 5 whose corresponding bits in the mask register CLRMSK (address 0A6H) are set.
- Additionally the Port 5 pins used for compare mode 2 may also be directly written to by write instructions to SFR P5. Of course, the pins can also be read under program control.

Compare registers CM0 to CM7 use additional compare latches when operated in mode 0. Figure 8 shows the function of these latches. The latches are implemented to prevent from loss of compare matches which may occur when loading of the compare values is not correlated with the timer count. The compare latches are automatically loaded from the compare registers at every timer overflow.

Capture

This feature permits saving of the actual timer/counter contents into a selected register upon an external event or a software write operation. Two modes are provided to 'freeze' the current 16-bit value of timer 2 registers into a dedicated capture register.

- Mode 0: Capture is performed in response to a transition at the corresponding port 1 pins CC0 to CC3.
- Mode 1: Write operation into the low-order byte of the dedicated capture register causes the timer 2 contents to be latched into this register.

Reload of Timer 2

A 16-bit reload can be performed with the 16-bit CRC register, which is a concatenation of the 8-bit registers CRCL and CRCH. There are two modes from which to select:

Mode 0: Reload is caused by a timer overflow (auto-reload).

Mode 1: Reload is caused in response to a negative transition at pin T2EX (P1.5), which can also request an interrupt.

Timer/Counters 0 and 1

These timer/counters are fully compatible with timer/counter 0 or 1 of the SAB 8051 and can operate in four modes:

Mode 0: 8-bit timer/counter with 32:1 prescaler

Mode 1: 16-bit timer/counter

Mode 2: 8-bit timer/counter with 8-bit auto reload

Mode 3: Timer/counter 0 is configured as one 8-bit timer; timer/counter 1 in this mode holds its count.

External inputs $\overline{\text{INT0}}$ and $\overline{\text{INT1}}$ can be programmed to function as a gate for timer/counters 0 and 1 to facilitate pulse width measurements.

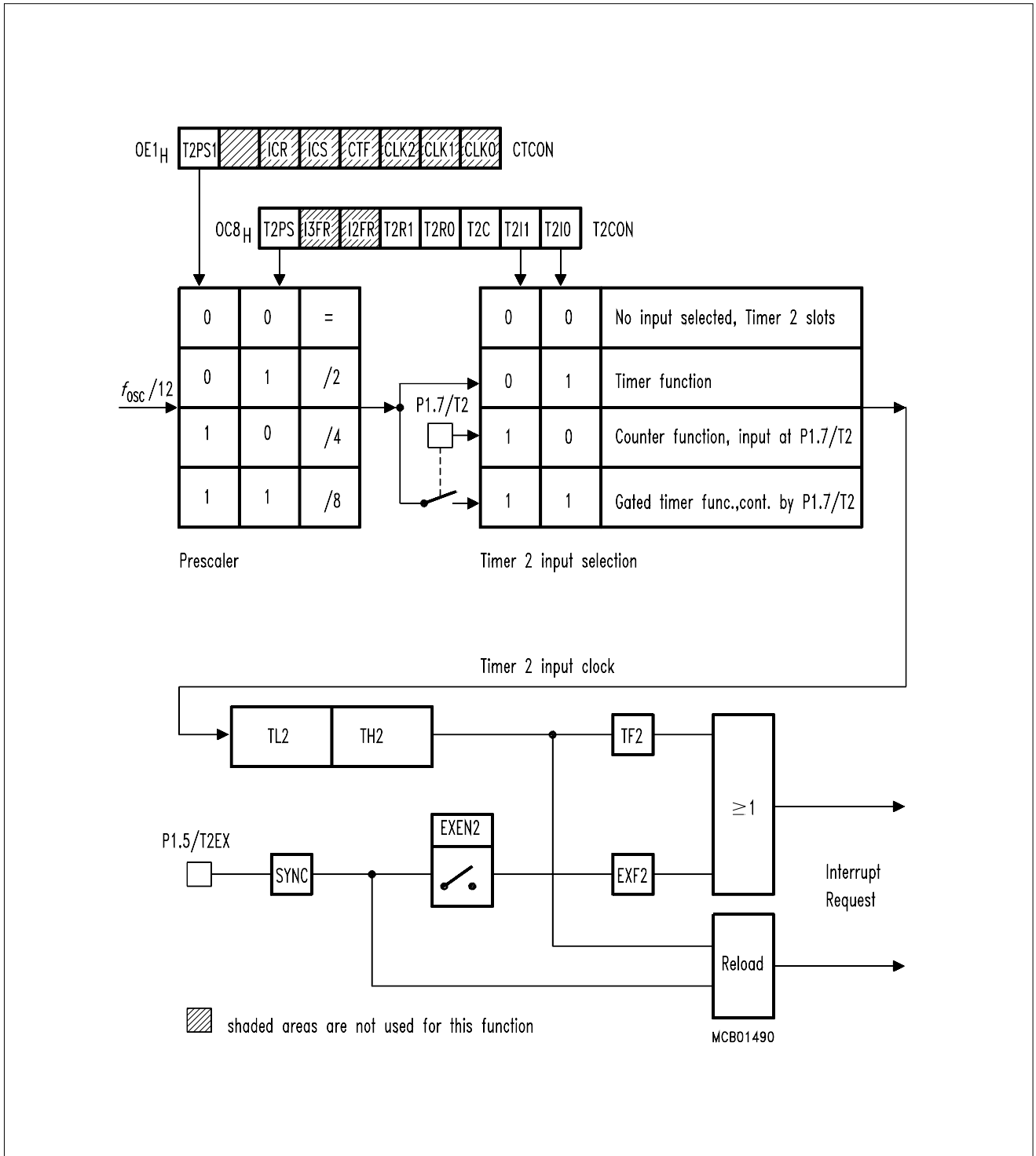


Figure 6
Block Diagram of Timer 2

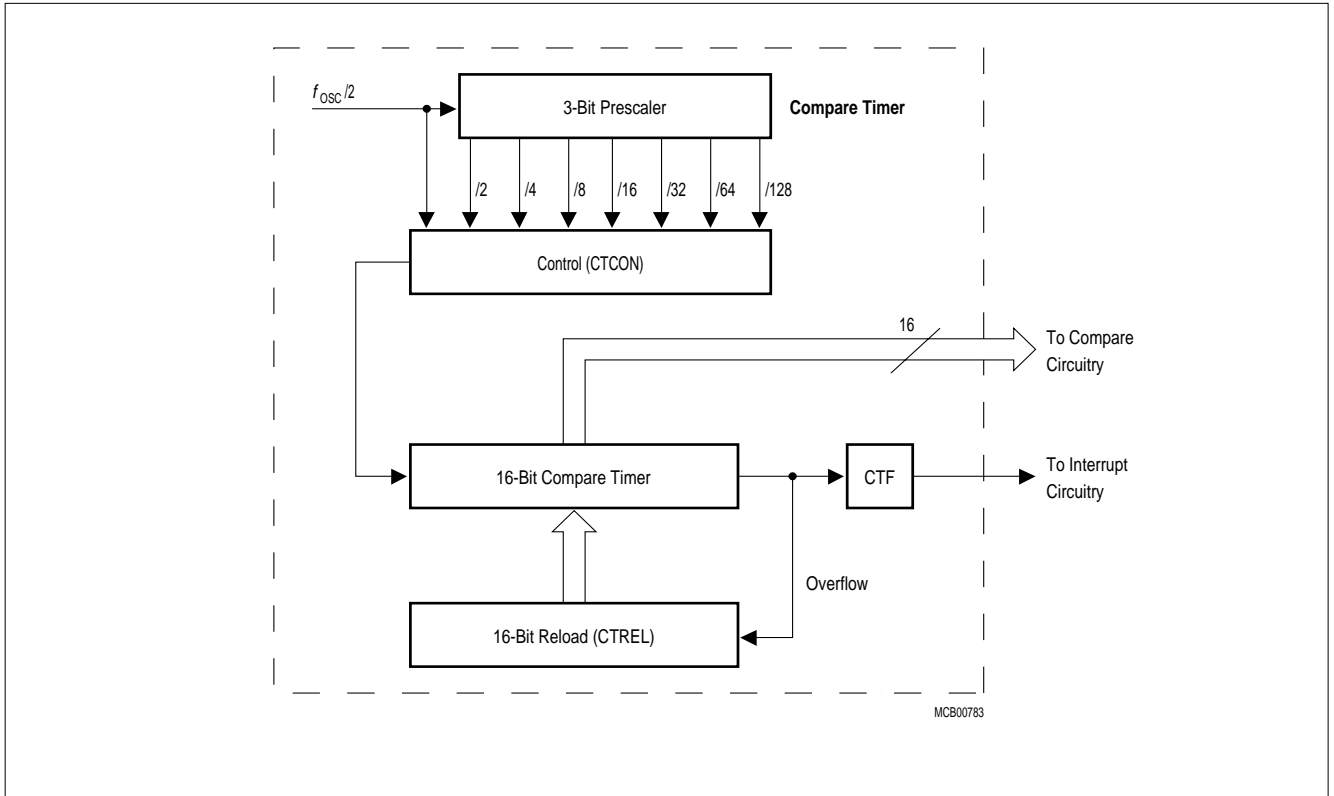


Figure 7
Block Diagram of the Compare Timer

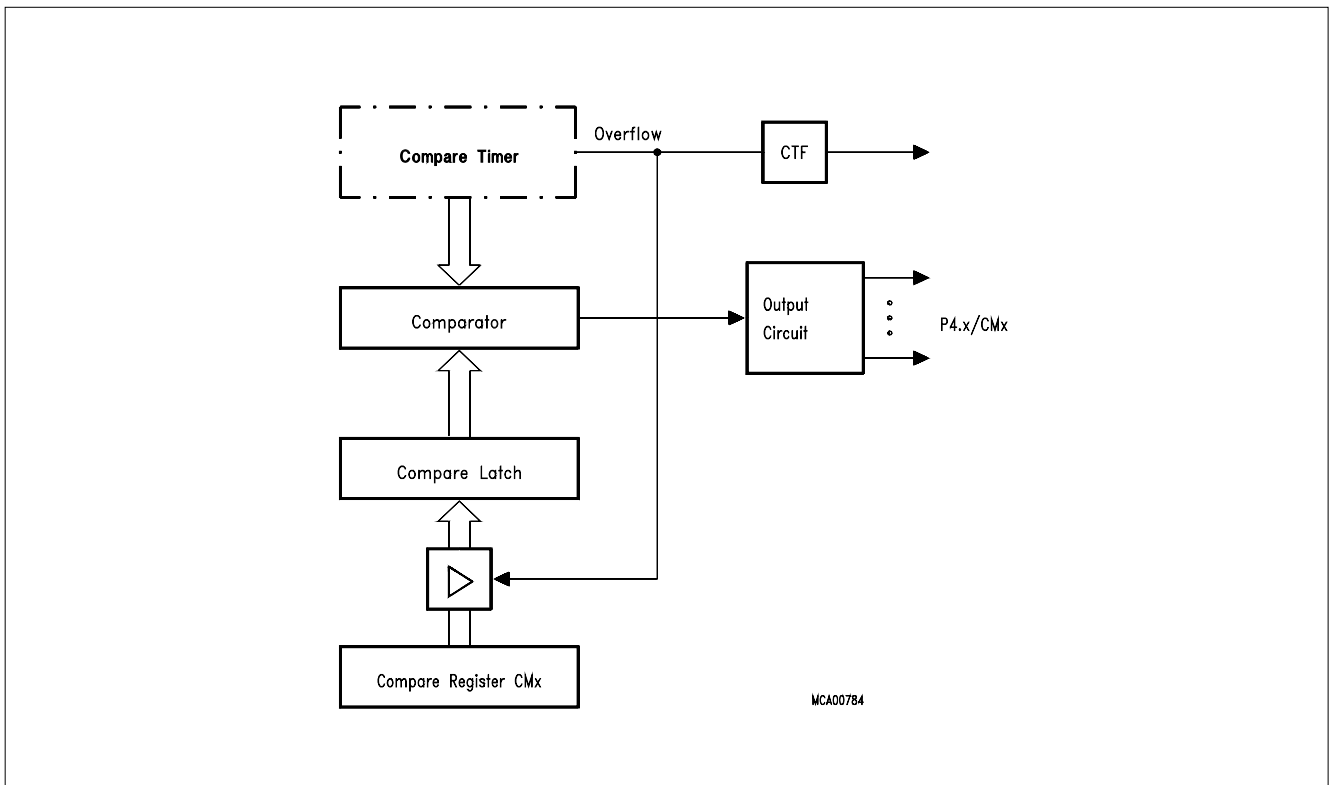


Figure 8
Compare-Mode 0 with Registers CM0 to CM7

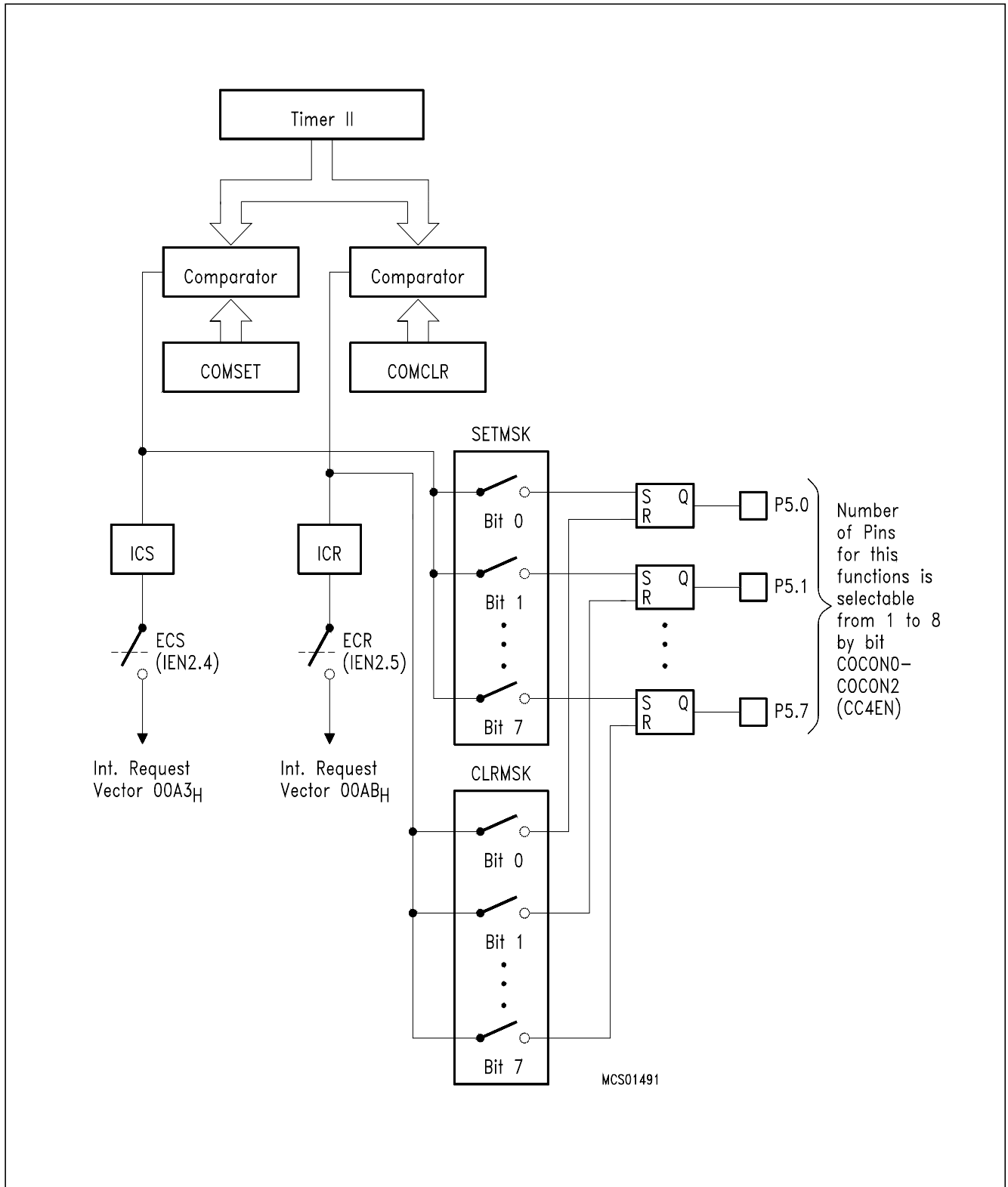


Figure 9
Compare-Mode 2 (Port 5 only)

Interrupt Structure

The SAB 80C517A has 17 interrupt vectors with the following vector addresses and request flags.

Table 5
Interrupt Sources and Vectors

Interrupt Request Flags	Interrupt Vector Address	Interrupt Source
IE0	0003 _H	External interrupt 0
TF0	000B _H	Timer 0 overflow
IE1	0013 _H	External interrupt 1
TF1	001B _H	Timer 1 overflow
RI0 + TI0	0023 _H	Serial channel 0
TF2 + EXF2	002B _H	Timer 2 overflow/ext. reload
IADC	0043 _H	A/D converter
IEX2	004B _H	External interrupt 2
IEX3	0053 _H	External interrupt 3
IEX4	005B _H	External interrupt 4
IEX5	0063 _H	External interrupt 5
IEX6	006B _H	External interrupt 6
RI1/TI1	0083 _H	Serial channel 1
ICMP0 to ICMP7	0093 _H	Compare match interrupt of Compare Registers CM0-CM7 assigned to Timer 2
CTF	009B _H	Compare timer overflow
ICS	00A3 _H	Compare match interrupt of Compare Register COMSET
ICR	00AB _H	Compare match interrupt of Compare Register COMCLR

Each interrupt vector can be individually enabled/disabled. The response time to an interrupt request is more than 3 machine cycles and less than 9 machine cycles.

External interrupts 0 and 1 can be activated by a low-level or a negative transition (selectable) at their corresponding input pin, external interrupts 2 and 3 can be programmed for triggering on a negative or a positive transition. The external interrupts 2 to 6 are combined with the corresponding alternate functions compare (output) and capture (input) on port 1.

For programming of the priority levels the interrupt vectors are combined to pairs or triples. Each pair or triple can be programmed individually to one of four priority levels by setting or clearing one bit in special function register IP0 and one in IP1. Figure 9 shows the interrupt request sources, the enabling and the priority level structure.

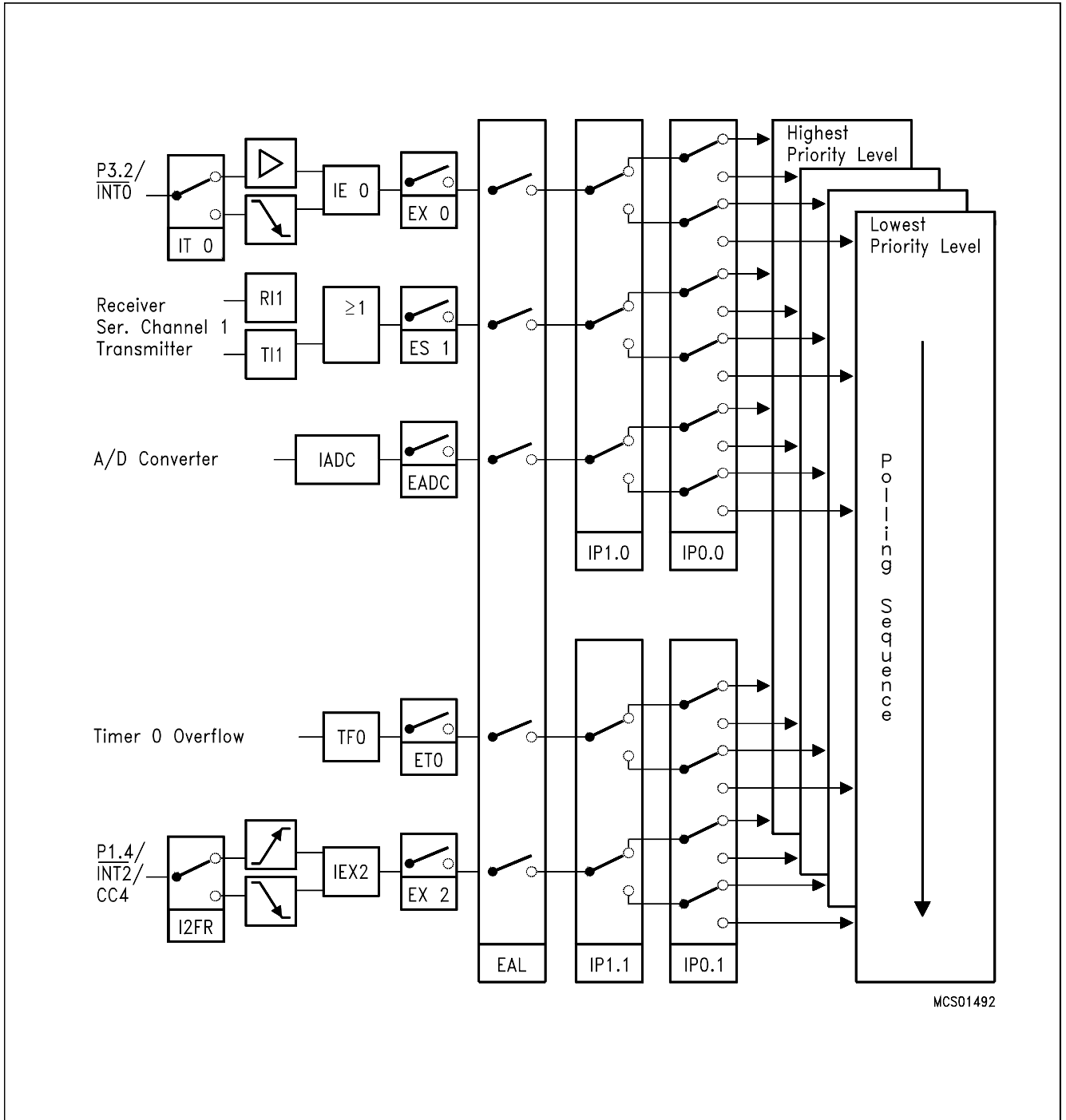


Figure 10
Interrupt Structure of the SAB 80C517A

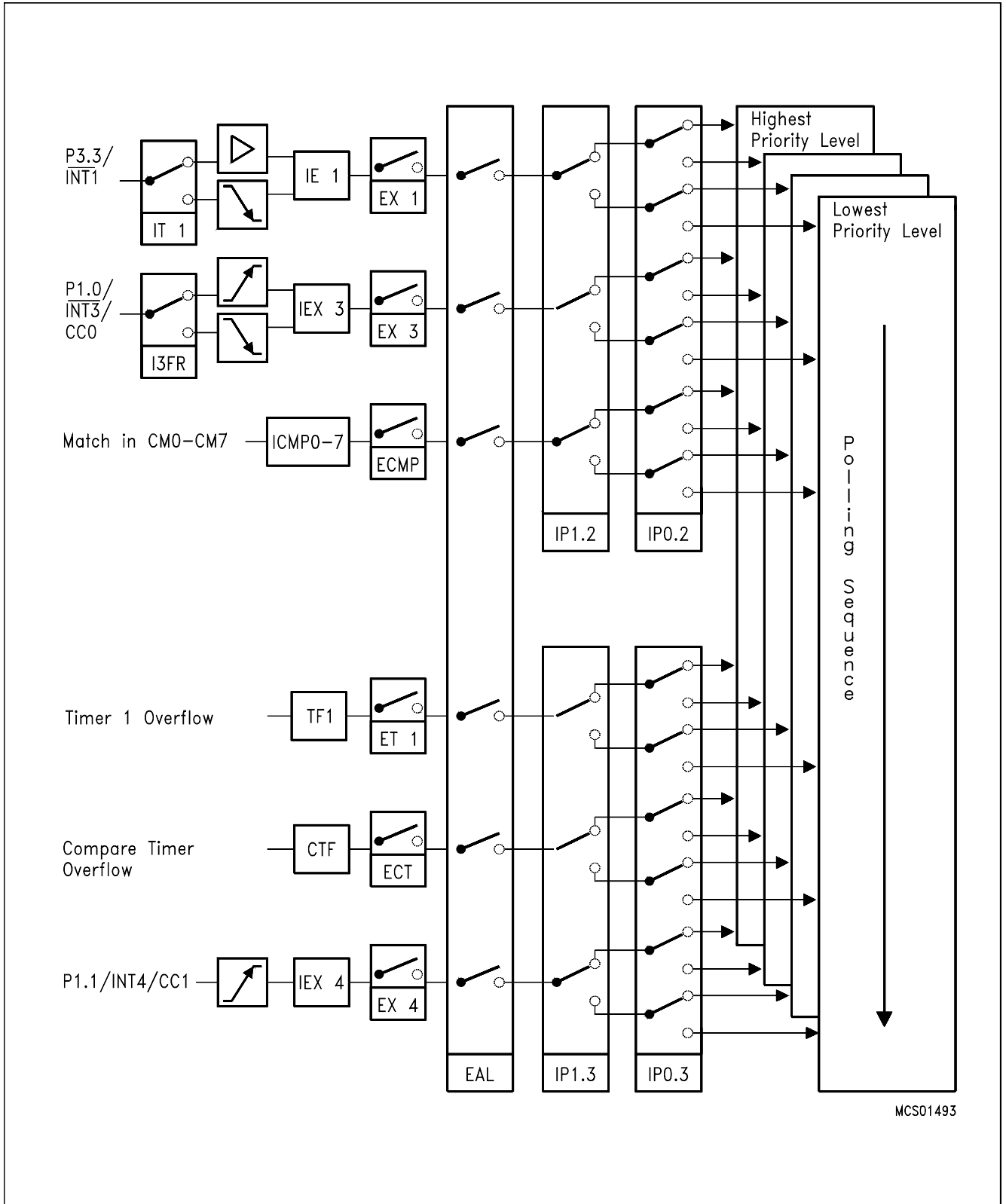


Figure 10
Interrupt Structure of the SAB 80C517A (cont'd)

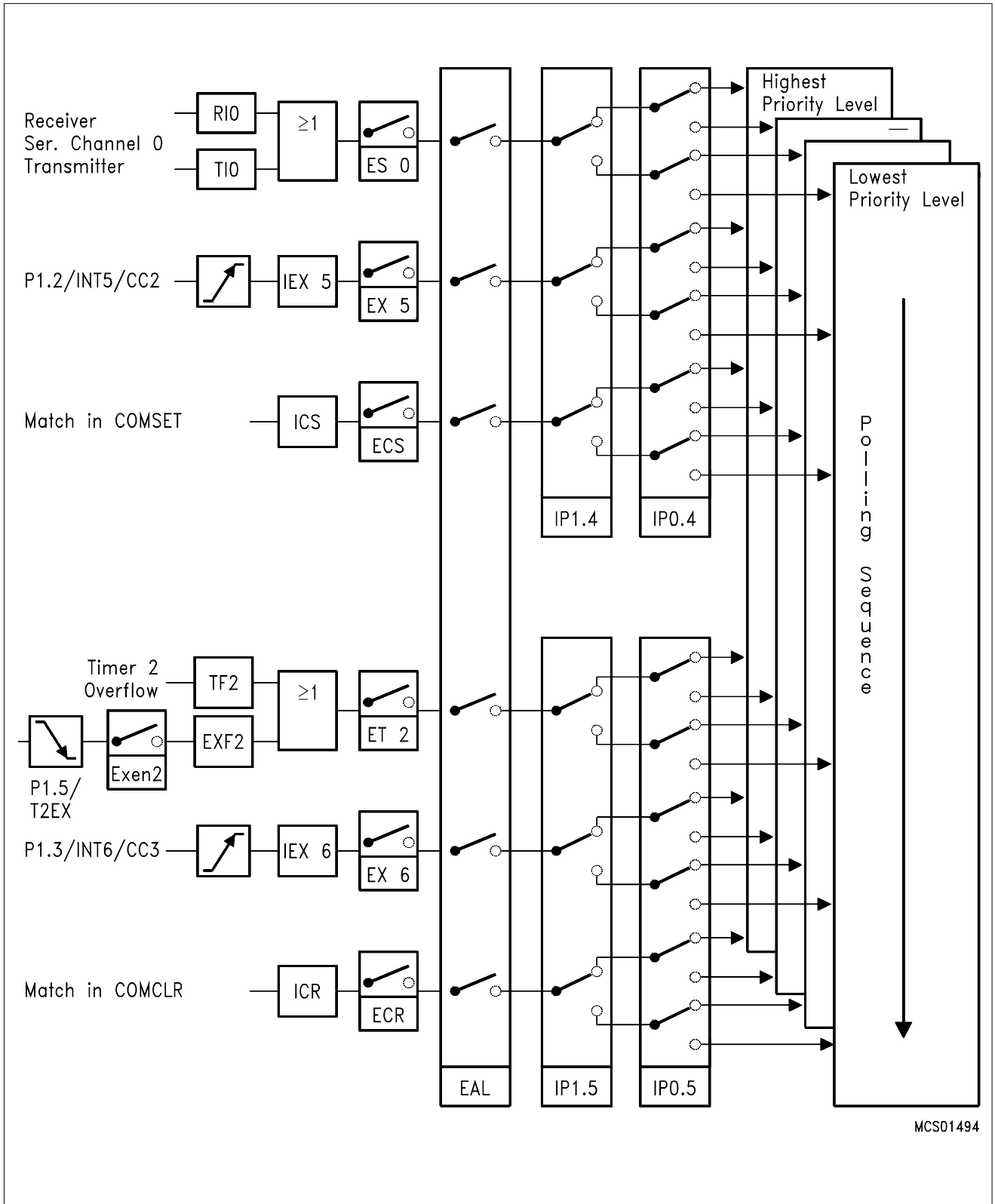


Figure 10
Interrupt Structure of the SAB 80C517A (cont'd)

Multiplication/Division Unit

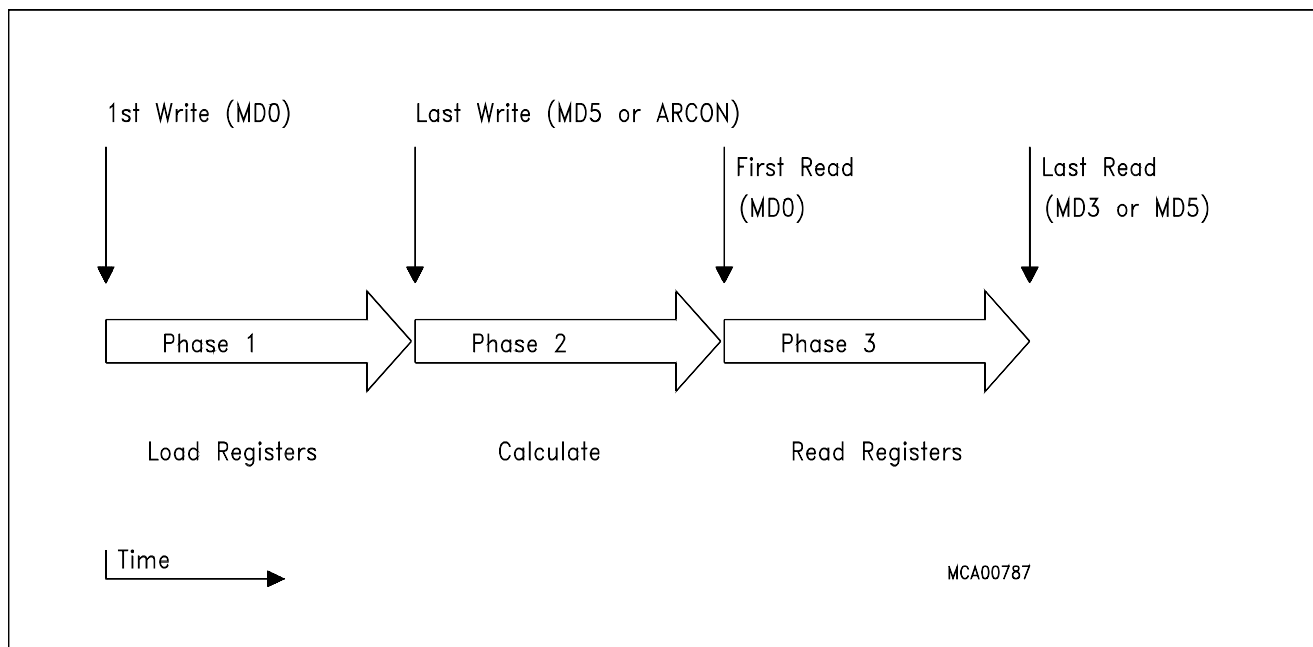
This on-chip arithmetic unit provides fast 32-bit division, 16-bit multiplication as well as shift and normalize features. All operations are integer operation.

Operation	Result	Remainder	Execution Time
32-bit/16-bit	32-bit	16-bit	$6 t_{cy}^{1)}$
16-bit/16-bit	16-bit	16-bit	$4 t_{cy}$
16-bit *16-bit	32-bit	—	$4 t_{cy}$
32-bit normalize	—	—	$6 t_{cy}^{2)}$
32-bit shift left/right	—	—	$6 t_{cy}^{2)}$

1) $1 t_{cy} = 1 \mu s$ @ 12 MHz oscillator frequency.

2) The maximal shift speed is 6 shifts/cycle.

The MDU consists of six registers used for operands and results and one control register. Operation of the MDU can be divided in three phases:



Operation of the MDU

To start an operation, register MD0 to MD5 (or ARCON) must be written to in a certain sequence according to table 5 or 6. The order the registers are accessed determines the type of the operation. A shift operation is started by a final write operation to register ARCON (see also the register description).

I/O Ports

The SAB 80C517A has seven 8-bit I/O ports and two input ports (8-bit and 4-bit wide).

Port 0 is an open-drain bidirectional I/O port, while ports 1 to 6 are quasi-bidirectional I/O ports with internal pull-up resistors. That means, when configured as inputs, ports 1 to 6 will be pulled high and will source current when externally pulled low. Port 0 will float when configured as input.

Port 0 and port 2 can be used to expand the program and data memory externally. During an access to external memory, port 0 emits the low-order address byte and reads/writes the data byte, while port 2 emits the high-order address byte. In this function, port 0 is not an open-drain port, but uses a strong internal pull-up FET. Port 1, 3, 4, 5 and port 6 provide several alternate functions. Please see the "Pin Description" for details.

Port pins show the information written to the port latches, when used as general purpose port. When an alternate function is used, the port pin is controlled by the respective peripheral unit. Therefore the port latch must contain a "one" for that function to operate. The same applies when the port pins are used as inputs. Ports 1, 3, 4 and 5 are bit-addressable.

The SAB 80C517A has two dual-purpose input ports. The twelve port lines at port 7 and port 8 can be used as analog inputs for the A/D converter. If input voltages at P7 and P8 meet the specified digital input levels (V_{IL} and V_{IH}) the port can also be used as digital input port.

In Hardware Power Down Mode the port pins and several control lines enter a floating state. For more details see the section about Hardware Power Down Mode.

Requirements for Hardware Power Down Mode

There is no dedicated pin to enable the Hardware Power Down Mode. Nevertheless for a correct function of the Hardware Power Down Mode the oscillator watchdog unit including its internal RC oscillator is needed. Therefore this unit must be enabled by pin OWE (OWE = high). However, the control pin \overline{PE}/SWD has no control function in this mode. It enables and disables only the use of software controlled power saving modes.

Software controlled power saving modes

All of these modes are entered by software. Special function register PCON (power control register, address is 87H) is used to select one of these modes.

Slow Down Mode

During slow down operation all signal frequencies that are derived from the oscillator clock, are divided by eight, also the clockout signal and the watchdog timer count.

The slow down mode is enabled by setting bit SD. The controller actually enters the slow down mode after a short synchronisation period (max. 2 machine cycles).

The slow down mode is disabled by clearing bit SD.

Idle Mode

During idle mode all peripherals of the SAB 80C517A (except for the watchdog timer) are still supplied by the oscillator clock. Thus the user has to take care which peripheral should continue to run and which has to be stopped during Idle.

The procedure to enter the idle mode is similar to the one entering the power down mode. The two bits IDLE and IDLS must be set by two consecutive instructions to minimize the chance of unintentional activating of the idle mode.

There are two ways to terminate the idle mode:

- The idle mode can be terminated by activating any enabled interrupt. This interrupt will be serviced and the instruction to be executed following the RETI instruction will be the one following the instruction that set the bit IDLS.
- The other way to terminate the idle mode, is a hardware reset. Since the oscillator is still running, the hardware reset must be held active only for two machine cycles for a complete reset.

Normally the port pins hold the logical state they had at the time idle mode was activated. If some pins are programmed to serve their alternate functions they still continue to output during idle mode if the assigned function is on. The control signals ALE and \overline{PSEN} hold at logic high levels \overline{PSEN} (see table 8).

Power Down Mode

The power down mode is entered by two consecutive instructions directly following each other. The first instruction has to set the flag PDE (power down enable) and must not set PDS (power down set). The following instruction has to set the start bit PDS. Bits PDE and PDS will automatically be cleared after having been set.

The instruction that sets bit PDS is the last instruction executed before going into power down mode. The only exit from power down mode is a hardware reset.

The status of all output lines of the controller can be looked up in table 8.

Hardware Controlled Power Down Mode

The pin $\overline{\text{HWPD}}$ controls this mode. If it is on logic high level (inactive) the part is running in the normal operating modes. If pin $\overline{\text{HWPD}}$ gets active (low level) the part enters the Hardware Power Down Mode; this is independent of the state of pin $\overline{\text{PE/SWD}}$.

$\overline{\text{HWPD}}$ is sampled once per machine cycle. If it is found active, the device starts a complete internal reset sequence. The watchdog timer is stopped and its status flag WDT5 is cleared exactly the same effects as a hardware reset. In this phase the power consumption is not yet reduced. After completion of the internal reset both oscillators of the chip are disabled. At the same time the port pins and several control lines enter a floating state as shown in table 8. In this state the power consumption is reduced to the power down current IPD. Also the supply voltage can be reduced. Table 8 also lists the voltages which may be applied at the pins during Hardware Power Down Mode without affecting the low power consumption.

Termination of HWPD Mode:

This power down state is maintained while pin $\overline{\text{HWPD}}$ is held active. If $\overline{\text{HWPD}}$ goes to high level (inactive state) an automatic start up procedure is performed:

- First the pins leave their floating condition and enter their default reset state (as they had immediately before going to float state).
- Both oscillators are enabled (only if OWE = high). The oscillator watchdog's RC oscillator starts up very fast (typ. less than 2 microseconds).
- Because the oscillator watchdog is active it detects a failure condition if the on-chip oscillator hasn't yet started. Hence, the watchdog keeps the part in reset and supplies the internal clock from the RC oscillator.
- Finally, when the on-chip oscillator has started, the oscillator watchdog releases the part from reset with oscillator watchdog status flag not set. When automatic start of the watchdog was enabled ($\overline{\text{PE/SWD}}$ connected to V_{CC}), the Watchdog Timer will start, too (with its default reload value for time-out period).
- The $\overline{\text{Reset}}$ pin overrides the Hardware Power Down function, i.e. if reset gets active during Hardware Power Down it is terminated and the device performs the normal reset function. (Thus, pin $\overline{\text{Reset}}$ has to be inactive during Hardware Power Down Mode).

Table 8
Status of all pins during Idle Mode, Power Down Mode and Hardware Power Down Mode

Pins	Idle Mode Last instruction executed from		Power Down Mode Last instruction executed from		Hardware Power Down	
	internal ROM	external ROM	internal ROM	external ROM	Status	Voltage range at pin
P0	Data	float	Data	float		
P1	Data alt outputs	Data alt outputs	Data last outputs	Data last outputs	floating	
P2	Data	Address	Data	Data	output	
P3	Data alt outputs	Data alt outputs	Data last output	Data last output	outputs	
P4	Data alt outputs	Data alt outputs	Data last outputs	Data last output	disabled	$V_{SS} \leq V_{IN} \leq V_{CC}$
P5	Data alt output	Data alt output	Data last output	Data last output	input	
P6	Data alt output	Data alt output	Data last output	Data last output	function	
P7						
P8						
EA					active input	$V_{IN} = V_{CC}$ or $V_{IN} = V_{SS}$
\overline{PE}/SWD					active input pull-up disabled	$V_{IN} = V_{CC}$ or $V_{IN} = V_{SS}$
XTAL1					active output	pin may not be driven
XTAL2					disabled input functions	$V_{SS} \leq V_{IN} \leq V_{CC}$

Table 8
Status of all pins during Idle Mode, Power Down Mode and Hardware Power Down Mode (cont'd)

Pins	Idle Mode Last instruction executed from		Power Down Mode Last instruction executed from		Hardware Power Down	
	internal ROM	external ROM	internal ROM	external ROM	Status	Voltage range at pin
$\overline{\text{PSEN}}$					floating outp. dis- abled input functions	$V_{SS} \leq V_{IN} \leq V_{CC}$
ALE						
VAREF VAGND					active sup- ply pins	$V_{AGND} \leq V_{IN} \leq V_{CC}$
OWE					active input, must be high pull-up disabl.	$V_{IN} = V_{CC}$
RESET					active input must be high	$V_{IN} = V_{CC}$
$\overline{\text{RO}}$					floating output	$V_{SS} \leq V_{IN} \leq V_{CC}$

Serial Interfaces

The SAB 80C517A has two serial interfaces. Both interfaces are full duplex and receive buffered. They are functionally identical with the serial interface of the SAB 8051 when working as asynchronous channels. Serial interface 0 additionally has a synchronous mode. Table 9 shows possible configurations and the according baud rates.

Table 9
Baud Rate Generation

8-Bit syn-chronous channel	Mode		Mode 0		–	
	Baud-rate	$f_{OSC} = 1$ 2 MHz	1MHz		–	
		$f_{OSC} =$ 16 MHz	1.33 MHz		–	
		$f_{OSC} =$ 18 MHz	1.5 MHz		–	
derived from		f_{OSC}			–	
8-Bit UART	Mode		Mode 1		Mode B	
	Baud-rate	$f_{OSC} =$ 12 MHz	1 Baud – 62.5 kBaud	183 Baud – 375 kBaud	366 Baud – 375 kBaud	
		$f_{OSC} =$ 16 MHz	1 Baud – 83 kBaud	244 Baud – 500 kBaud	244 Baud – 500 kBaud	
		$f_{OSC} =$ 18 MHz	1 Baud – 93.7 kBaud	2375 Baud – 562.5 kBaud	549 Baud – 562.5 kBaud	
derived from		Timer 1	10-Bit Baudrate Generator	10-Bit Baudrate Generator		
9-Bit UART	Mode		Mode 2	Mode 3		Mode A
	Baud-rate	$f_{OSC} =$ 12 MHz	187.5 kBaud/ 375 kBaud	1 Baud – 62.5 kBaud	183 Baud – 75 kBaud	183 Baud – 75 kBaud
		$f_{OSC} =$ 16 MHz	250 Baud/ 500 kBaud	1 Baud – 83.3 kBaud	244 Baud – 500 kBaud	244 Baud – 500 kBaud
		$f_{OSC} =$ 18 MHz	281.2 kBaud/ 562.5 kBaud	1 Baud – 93.7 kBaud	275 Baud 562.5 kBaud	549 Baud – 562.5 kBaud
derived from	$f_{OSC}/2$	Timer 1	10-Bit Baudrate Generator		10-Bit Baudrate Generator	

Serial Interface 0

Serial Interface 0 can operate in 4 modes:

- Mode 0: Shift register mode:
Serial data enters and exits through R × D0. T × D0 outputs the shift clock 8 data bits are transmitted/received (LSB first). The baud rate is fixed at 1/12 of the oscillator frequency.
- Mode 1: 8-bit UART, variable baud rate:
10-bit are transmitted (through T × D0) or received (through R × D0): a start bit (0), 8 data bits (LSB first), and a stop bit (1). On reception, the stop bit goes into RB80 in special function register S0CON. The baud rate is variable.
- Mode 2: 9-bit UART, fixed baud rate:
11-bit are transmitted (through T × D0) or received (through R × D0): a start bit (0), 8 data bits (LSB first), a programmable 9th, and a stop bit (1). On transmission, the 9th data bit (TB80 in S0CON) can be assigned to the value of 0 or 1. For example, the parity bit (P in the PSW) could be moved into TB80 or a second stop bit by setting TB80 to 1. On reception the 9th data bit goes into RB80 in special function register S0CON, while the stop bit is ignored. The baud rate is programmable to either 1/32 or 1/64 of the oscillator frequency.
- Mode 3: 9-bit UART, variable baud rate:
11-bit are transmitted (through T × D0) or received (through R × D0): a start bit (0), 8 data bits (LSB first), a programmable 9th, and a stop bit (1). In fact, mode 3 is the same as mode 2 in all respects except the baud rate. The baud rate in mode 3 is variable.

Variable Baud Rates for Serial Interface 0

Variable baud rates for modes 1 and 3 of serial interface 0 can be derived from either timer 1 or a dedicated Baudrate Generator.

The baud rate is generated by a free running 10-bit timer with programmable reload register.

$$\text{Mode 1.3 baud rate} = \frac{2^{\text{SMOD}} * f_{\text{osc}}}{64 * (2^{10} - \text{S0REL})}$$

The default value after reset in the reload registers S0RELL and S0RELH provide a baud rate of 4.8 kBaud (SMOD = 0) or 9.6 kBaud (SMOD = 1) at 12 MHz oscillator frequency. This guarantees full compatibility to the SAB 80C517.

Serial Interface 1

Serial interface 1 can operate in two asynchronous modes:

Mode A: 9-bit UART, variable baud rate.

11 bits are transmitted (through T × D1) or received (through R × D1): a start bit (0), 8 data bits (LSB first), a programmable 9th, and a stop bit (1). On transmission, the 9th data bit (TB81 in S1CON) can be assigned to the value of 0 or 1. For example, the parity bit (P in the PSW) could be moved into TB81 or a second stop bit by setting TB81 to 1. On reception the 9th data bit goes into RB81 in special function register S1CON, while the stop bit is ignored.

Mode B: 8-bit UART, variable baud rate.

10 bits are transmitted (through T × D1) or received (through R × D1): a start bit (0), 8 data bits (LSB first), and a stop bit (1). On reception, the stop bit goes into RB81 in special function register S1CON.

Variable Baud Rates for Serial Interface 1.

Variable baud rates for modes A and B of serial interface 1 are derived from a dedicated baud rate generator.

The baud rate clock (baud rate = $\frac{\text{baud rate clock}}{16}$) is generated by an 10-bit free running timer with programmable reload register.

$$\text{Mode A, B baudrate} = \frac{f_{\text{osc}}}{32 * (2^{10} - \text{SREL})}$$

Oscillator Watchdog

The unit serves three functions:

- Monitoring of the on-chip oscillator's function.
The watchdog supervises the on-chip oscillator's frequency; if it is lower than the frequency of the auxiliary RC oscillator in the watchdog unit, the internal clock is supplied by the RC oscillator and the device is forced into reset; if the failure condition disappears (i.e. the on-chip oscillator has again a higher frequency than the RC oscillator), the part executes a final reset phase of appr. 0.25 ms in order to allow the oscillator to stabilize; then the oscillator watchdog reset is released and the part starts program execution again.
- Restart from the Hardware Power Down Mode.
If the Hardware Power Down Mode is terminated the oscillator watchdog has to control the correct start-up of the on-chip oscillator and to restart the program. The oscillator watchdog function is only part of the complete Hardware Power Down sequence; however, the watchdog works identically to the monitoring function.
- Fast internal reset after power-on.
In this function the oscillator watchdog unit provides a clock supply for the reset before the on-chip oscillator has started. In this case the oscillator watchdog unit also works identically to the monitoring function.

If the oscillator watchdog unit is to be used it must be enabled (this is done by applying high level to the control pin OWE).

Figure 12 shows the block diagram of the oscillator watchdog unit. It consists of an internal RC oscillator which provides the reference frequency of the on-chip oscillator. The RC oscillator can be enabled/disabled by the control pin OWE. If it is disabled the complete unit has no function.

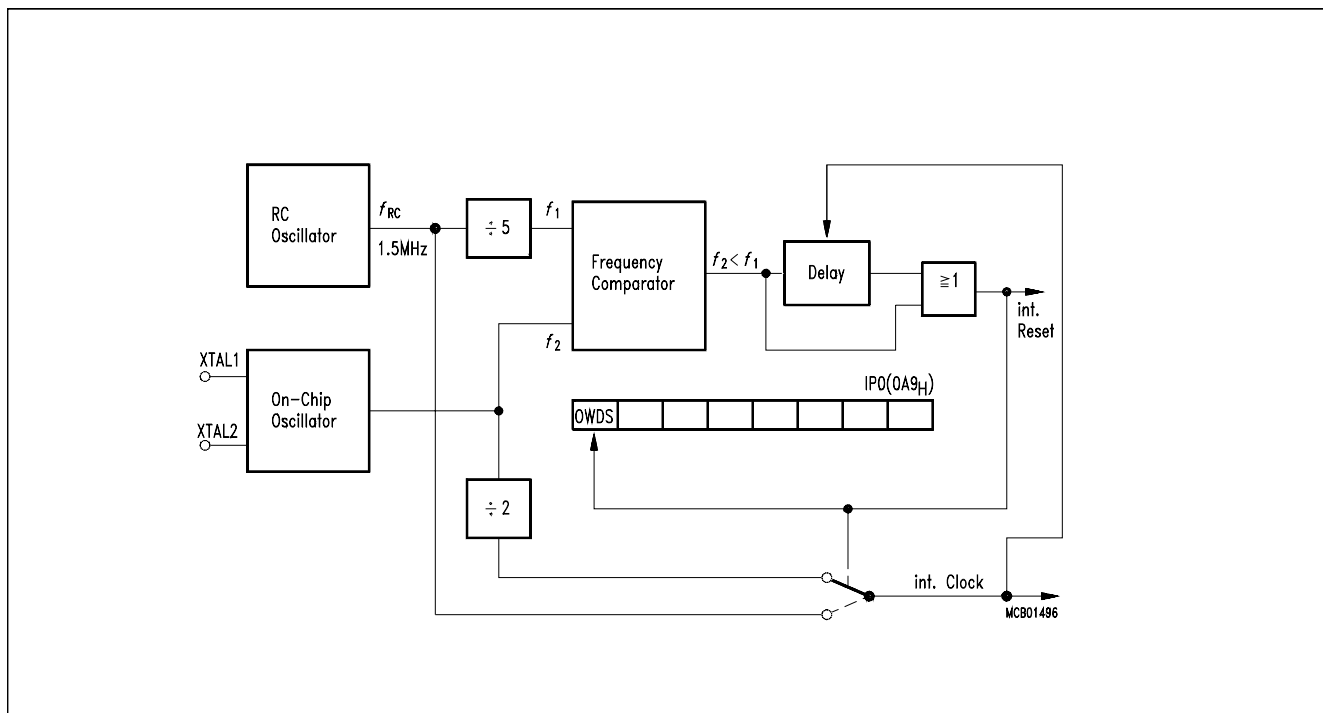


Figure 12
Functional Block Diagram of the Oscillator Watchdog

Fast internal reset after power-on

The SAB 80C517A can use the oscillator watchdog unit for a fast internal reset procedure after power-on.

Normally members of the 8051 family (like the SAB 80C517) enter their default reset state not before the on-chip oscillator starts. The reason is that the external reset signal must be internally synchronized and processed in order to bring the device into the correct reset state. Especially if a crystal is used the start up time of the oscillator is relatively long (typ. 1 ms). During this time period the pins have an undefined state which could have severe effects e.g. to actuators connected to port pins.

In the SAB 80C517A the oscillator watchdog unit avoids this situation. However, the oscillator watchdog must be enabled. In this case, after power-on the oscillator watch-dog's RC oscillator starts working within a very short start-up time (typ. less than 2 micro-seconds). In the following the watchdog circuitry detects a failure condition for the on-chip oscillator because this has not yet started (a failure is always recognized if the watchdog's RC oscillator runs faster than the on-chip oscillator). As long as this condition is valid the watchdog uses the RC oscillator output as clock source for the chip rather than the on-chip oscillator's output. This allows correct resetting of the part and brings also all ports to the defined state.

Delay time between power-on and correct reset state:

Typ.: 18 μ s

Max.: 34 μ s

Instruction Set

The SAB 80C517A / 83C517A-5 has the same instruction set as the industry standard 8051 microcontroller.

A pocket guide is available which contains the complete instruction set in functional and hexadecimal order. Furtheron it provides helpful information about Special Function Registers, Interrupt Vectors and Assembler Directives.

Literature Information

Title	Ordering No.
Microcontroller Family SAB 8051 Pocket Guide	B158-H6497-X-X-7600

Absolute Maximum Ratings

Ambient temperature under bias.....	- 40 to 110° C
Storage temperature	- 65 to 150 °C
Voltage on V_{CC} pins with respect to ground (V_{SS})	- 0.5 V to 6.5 V
Voltage on any pin with respect to ground (V_{SS})	- 0.5 to $V_{CC} + 0.5$ V
Input current on any pin during overload condition	- 10mA to +10mA
Absolute sum of all input currents during overload condition.....	100mA
Power dissipation	1 W

Note Stresses above those listed under “Absolute Maximum Ratings” may cause permanent damage of the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for longer periods may affect device reliability. During overload conditions ($V_{IN} > V_{CC}$ or $V_{IN} < V_{SS}$) the voltage on V_{CC} pins with respect to ground (V_{SS}) must not exceed the values defined by the absolute maximum ratings.

DC Characteristics

$V_{CC} = 5\text{ V} + 10\%, -15\%$; $V_{SS} = 0\text{ V}$

$T_A = 0$ to 70 °C for the SAB 80C517A/83C517A-5

$T_A = -40$ to 85 °C for the SAB 80C517A-T3/83C517A-5-T3

$T_A = -40$ to 110 °C for the SAB 80C517A-T4/83C517A-5-T4

Parameter	Symbol	Limit Values		Unit	Test Condition
		min.	max.		
Input low voltage (except \overline{EA} , \overline{RESET} , \overline{HWPD})	V_{IL}	- 0.5	$0.2 V_{CC} - 0.1$	V	-
Input low voltage (\overline{EA})	V_{IL1}	- 0.5	$0.2 V_{CC} - 0.3$	V	-
Input low voltage (\overline{HWPD} , \overline{RESET})	V_{IL2}	- 0.5	$0.2 V_{CC} + 0.1$	V	-
Input high voltage (except \overline{RESET} , XTAL2 and \overline{HWPD})	V_{IH}	$0.2 V_{CC} + 0.9$	$V_{CC} + 0.5$	V	-
Input high voltage to XTAL2	V_{IH1}	$0.7 V_{CC}$	$V_{CC} + 0.5$	V	-
Input high voltage to \overline{RESET} and \overline{HWPD}	V_{IH2}	$0.6 V_{CC}$	$V_{CC} + 0.5$	V	-

DC Characteristics (cont'd)

Parameter	Symbol	Limit Values		Unit	Test condition
		min.	max.		
Output low voltage (ports 1, 2, 3, 4, 5, 6)	V_{OL}	–	0.45	V	$I_{OL}=1.6 \text{ mA}^1)$
Output low voltage (ports ALE, $\overline{\text{PSEN}}$, $\overline{\text{RO}}$)	V_{OL1}	–	0.45	V	$I_{OL}=3.2 \text{ mA}^1)$
Output high voltage (ports 1, 2, 3, 4, 5, 6)	V_{OH}	2.4 $0.9 V_{CC}$	– –	V V	$I_{OH} = -80 \mu\text{A}$ $I_{OH} = -10 \mu\text{A}$
Output high voltage (port 0 in external bus mode, ALE, $\overline{\text{PSEN}}$, $\overline{\text{RO}}$)	V_{OH1}	2.4 $0.9 V_{CC}$	– –	V V	$I_{OH} = -800 \mu\text{A}^2)$ $I_{OH} = -80 \mu\text{A}^2)$
Logic input low current (ports 1, 2, 3, 4, 5, 6)	I_{IL}	– 10	– 70	μA	$V_{IN} = 0.45 \text{ V}$
Logical 1-to-0 transition current (ports 1, 2, 3, 4, 5, 6)	I_{TL}	– 65	– 650	μA	$V_{IN} = 2 \text{ V}$
Input leakage current (port 0, $\overline{\text{EA}}$, ports 7, 8, $\overline{\text{HWPD}}$)	I_{LI}	–	± 100 ± 150	nA nA	$0.45 < V_{IN} < V_{CC}$ $0.45 < V_{IN} < V_{CC}$ $T_A > 100^\circ\text{C}$
Input low current to $\overline{\text{RESET}}$ for reset	I_{IL2}	– 10	–100	μA	$V_{IN} = 0.45 \text{ V}$
Input low current (XTAL2)	I_{IL3}	–	– 15	μA	$V_{IN} = 0.45 \text{ V}$
Input low current ($\overline{\text{PE}}/\text{SWD}$, OWE)	I_{IL4}	–	– 20	μA	$V_{IN} = 0.45 \text{ V}$
Pin capacitance	C_{IO}	–	10	pF	$f_C = 1 \text{ MHz}$ $T_A = 25^\circ\text{C}$
Power supply current: Active mode, 12 MHz ⁷⁾	I_{CC}	–	28	mA	$V_{CC} = 5 \text{ V},^4)$
Active mode, 18 MHz ⁷⁾	I_{CC}	–	37	mA	$V_{CC} = 5 \text{ V},^4)$
Idle mode, 12 MHz ⁷⁾	I_{CC}	–	24	mA	$V_{CC} = 5 \text{ V},^5)$
Idle mode, 18 MHz ⁷⁾	I_{CC}	–	31	mA	$V_{CC} = 5 \text{ V},^5)$
Slow down mode, 12 MHz	I_{CC}	–	12	mA	$V_{CC} = 5 \text{ V},^6)$
Slow down mode, 18 MHz	I_{CC}	–	16	mA	$V_{CC} = 5 \text{ V},^6)$
Power Down Mode	I_{PD}	–	50	μA	$V_{CC} = 2 \dots 5.5 \text{ V},^3)$

Notes see page 61.

Notes for page 62:

- 1) Capacitive loading on ports 0 and 2 may cause spurious noise pulses to be superimposed on the V_{OL} of ALE and ports 1, 3, 4, 5 and 6. The noise is due to external bus capacitance discharging into the port 0 and port 2 pins when these pins make 1-to-0 transitions during bus operation. In the worst case (capacitive loading > 100 pF), the noise pulse on ALE line may exceed 0.8 V. In such cases it may be desirable to qualify ALE with a schmitt-trigger, or use an address latch with a schmitt-trigger strobe input.
- 2) Capacitive loading on ports 0 and 2 may cause the V_{OH} on ALE and \overline{PSEN} to momentarily fall below the $0.9 V_{CC}$ specification when the address lines are stabilizing.
- 3) I_{PD} (Power down mode) is measured with:
 $\overline{EA} = \overline{RESET} = V_{CC}$; Port0 = Port7 = Port8 = V_{CC} ; XTAL1 = N.C.; XTAL2 = V_{SS} ;
 $\overline{PE/SWD} = \overline{OWE} = V_{SS}$; $\overline{HWDP} = V_{CC}$ (Software Power Down mode); $V_{ARef} = V_{CC}$;
 $V_{AGND} = V_{SS}$; all other pins are disconnected. Hardware Powerdown I_{PD} : $\overline{OWE} = V_{CC}$
 or V_{SS} . No certain pin connection for the other pins.
- 4) I_{CC} (active mode) is measured with:
 XTAL2 driven with t_{CLCH} , $t_{CHCL} = 5$ ns, $V_{IL} = V_{SS} + 0.5$ V, $V_{IH} = V_{CC} - 0.5$ V; XTAL1 = N.C.;
 $\overline{EA} = \overline{PE/SWD} = V_{CC}$; Port0 = Port7 = Port8 = V_{CC} ; $\overline{HWPD} = V_{CC}$; $\overline{RESET} = V_{SS}$
 all other pins are disconnected. I_{CC} would be slightly higher if a crystal oscillator is
 used (appr. 1 mA).
- 5) I_{CC} (Idle mode) is measured with all output pins disconnected and with all peripherals
 disabled; XTAL2 driven with t_{CLCH} , $t_{CHCL} = 5$ ns, $V_{IL} = V_{SS} + 0.5$ V, $V_{IH} = V_{CC} - 0.5$ V;
 XTAL1 = N.C.; $\overline{RESET} = V_{CC}$; $\overline{HWPD} = V_{CC}$; Port0 = Port7 = Port8 = V_{CC} ;
 $\overline{EA} = \overline{PE/SWD} = V_{SS}$; all other pins are disconnected;
- 6) I_{CC} (slow down mode) is measured with all output pins disconnected and with all peripher-
 als disabled; XTAL2 driven with t_{CLCH} , $t_{CHCL} = 5$ ns, $V_{IL} = V_{SS} + 0.5$ V, $V_{IH} = V_{CC} - 0.5$ V;
 XTAL1 = N.C.; $\overline{RESET} = V_{CC}$; $\overline{HWPD} = V_{CC}$; Port7 = Port8 = V_{CC} ; $\overline{EA} = \overline{PE/SWD} = V_{SS}$;
 all other pins are disconnected;
- 7) $I_{CC \text{ Max}}$ at other frequencies is given by:
 active mode: $I_{CC} (\text{max}) = 1.50 * f_{OSC} + 10$
 idle mode: $I_{CC} (\text{max}) = 1.17 * f_{OSC} + 10$
 where f_{OSC} is the oscillator frequency in MHz. I_{CC} values are given in mA and
 measured at $V_{CC} = 5$ V.

A/D Converter Characteristics

$V_{CC} = 5 \text{ V} + 10\%, -15\%$; $V_{SS} = 0 \text{ V}$

$V_{AREF} = V_{CC} \pm 5\%$; $V_{AGND} = V_{SS} \pm 0.2 \text{ V}$;

$T_A = 0 \text{ to } 70 \text{ }^\circ\text{C}$ for the SAB 80C517A/83C517A-5

$T_A = -40 \text{ to } 85 \text{ }^\circ\text{C}$ for the SAB 80C517A-T3/83C517A-5-T3

$T_A = -40 \text{ to } 110 \text{ }^\circ\text{C}$ for the SAB 80C517A-T4/83C517A-5-T4

Parameter	Symbol	Limit values			Unit	Test condition
		min.	typ.	max.		
Analog input capacitance	C_I		25	70	pF	
Sample time (inc. load time)	T_S			$4 t_{CY}^{(1)}$	μS	²⁾
Conversion time (inc. sample time)	T_C			$14 t_{CY}^{(1)}$	μS	³⁾
Total unadjusted error	TUE			± 2	LSB	$V_{AREF} = V_{CC}$ $V_{AGND} = V_{SS}$
V_{AREF} supply current	I_{REF}		± 20		μA	⁴⁾

¹⁾ $t_{CY} = (8 \cdot 2^{ADCL}) / f_{OSC}$; ($t_{CY} = 1/f_{ADC}$; $f_{ADC} = f_{OSC} / (8 \cdot 2^{ADCL})$)

²⁾ This parameter specifies the time during the input capacitance C_I can be charged/discharged by the external source. It must be guaranteed, that the input capacitance C_I , is fully loaded within this time. $4TCY$ is $2 \mu\text{s}$ at the $f_{OSC} = 16 \text{ MHz}$. After the end of the sample time T_S , changes of the analog input voltage have no effect on the conversion result.

³⁾ This parameter includes the sample time T_S . $14TCY$ is $7 \mu\text{s}$ at $f_{OSC} = 16 \text{ MHz}$.

⁴⁾ The differential impedance r_D of the analog reference source must be less than $1 \text{ K}\Omega$ at reference supply voltage.

AC Characteristics

$V_{CC} = 5\text{ V} + 10\%, -15\%$; $V_{SS} = 0\text{ V}$

$T_A = 0\text{ to }70\text{ }^\circ\text{C}$ for the SAB 80C517A/83C517A-5

$T_A = -40\text{ to }85\text{ }^\circ\text{C}$ for the SAB 80C517A-T3/83C517A-5-T3

$T_A = -40\text{ to }110\text{ }^\circ\text{C}$ for the SAB 80C517A-T4/83C517A-5-T4

(C_L for port 0, ALE and $\overline{\text{PSEN}}$ outputs = 100 pF; C_L for all other outputs = 80 pF)

Parameter	Symbol	Limit Values				Unit
		18 MHz Clock		Variable Clock $1/t_{CLCL} = 3.5\text{ MHz to }18\text{ MHz}$		
		min.	max.	min.	max.	

Program Memory Characteristics

ALE pulse width	t_{LHLL}	71	–	$2 t_{CLCL} - 40$	–	ns
Address setup to ALE	t_{AVLL}	26	–	$t_{CLCL} - 30$	–	ns
Address hold after ALE	t_{LLAX}	26	–	$t_{CLCL} - 30$	–	ns
ALE to valid instruction	t_{LLIV}	–	122	–	$4t_{CLCL} - 100$	ns
ALE to $\overline{\text{PSEN}}$	t_{LLPL}	31	–	$t_{CLCL} - 25$	–	ns
$\overline{\text{PSEN}}$ pulse width	t_{PLPH}	132	–	$3 t_{CLCL} - 35$	–	ns
$\overline{\text{PSEN}}$ to valid instruction	t_{PLIV}	–	92	–	$3t_{CLCL} - 75$	ns
Input instruction hold after $\overline{\text{PSEN}}$	t_{PXIX}	0	–	0	–	ns
Input instruction float after $\overline{\text{PSEN}}$	t_{PXIZ}	–	46	–	$t_{CLCL} - 10$	ns
Address valid after $\overline{\text{PSEN}}$	$t_{PXAV}^*)$	48	–	$t_{CLCL} - 8$	–	ns
Address to valid instr in	t_{AVIV}	–	218	–	$5t_{CLCL} - 60$	ns
Address float to $\overline{\text{PSEN}}$	t_{AZPL}	0	–	0	–	ns

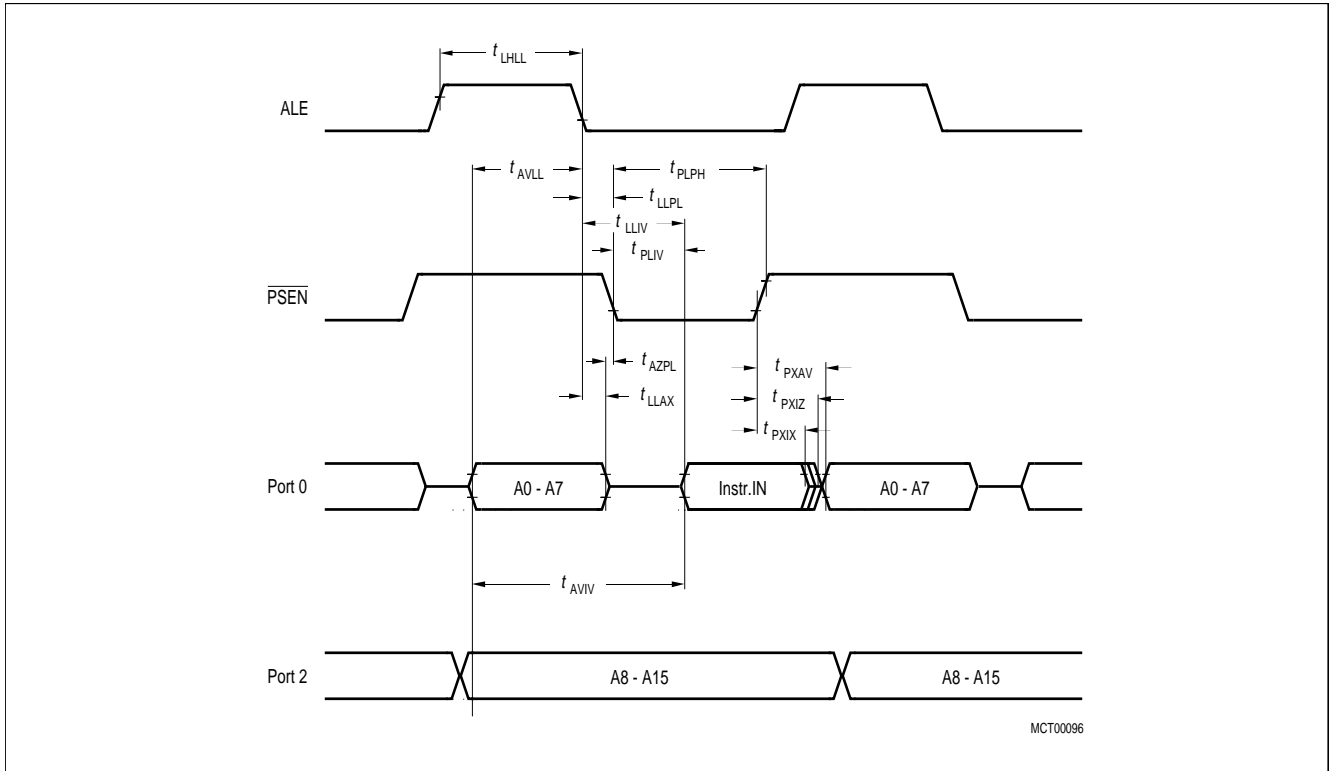
*) Interfacing the SAB 80C517A to devices with float times up to 45 ns is permissible. This limited bus contention will not cause any damage to port 0 drivers.

AC Characteristics (cont'd)

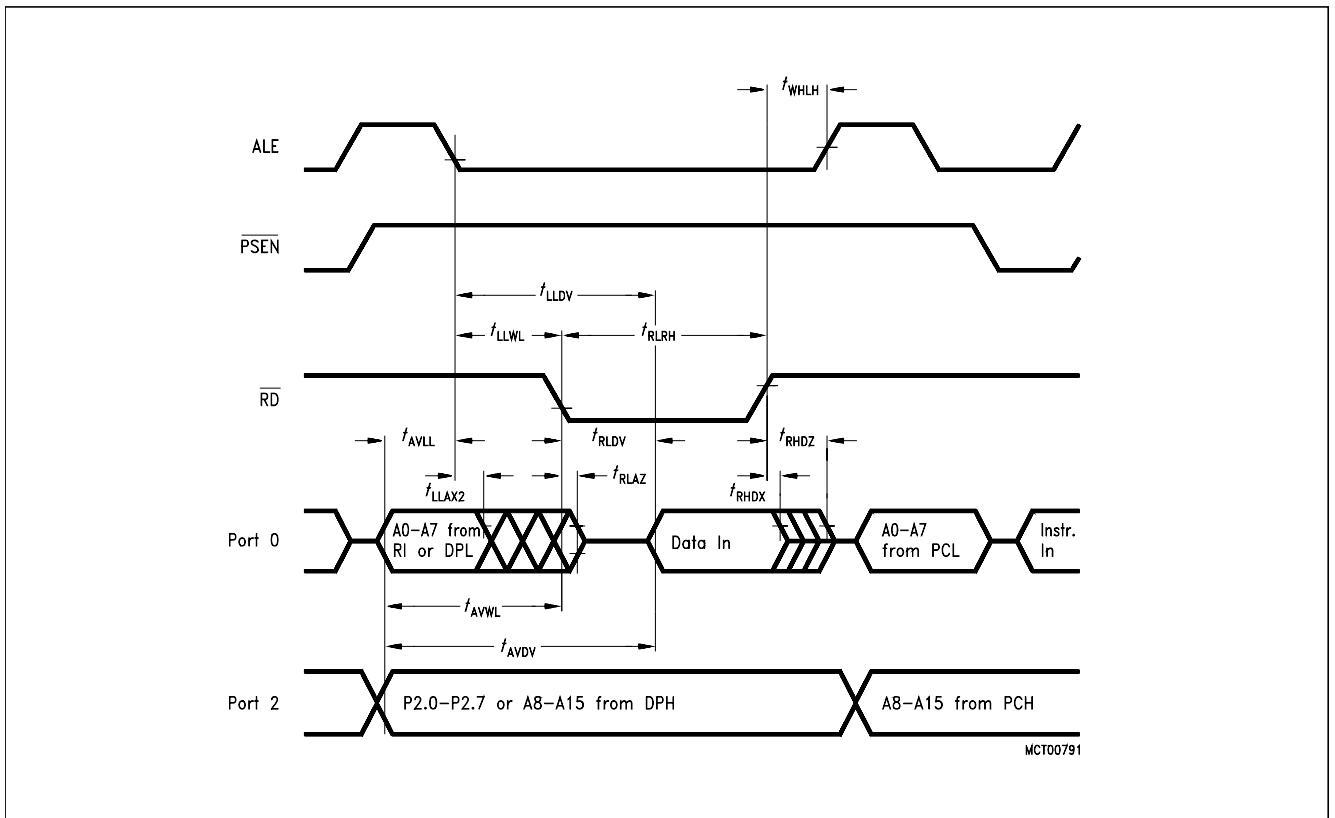
Parameter	Symbol	Limit Values				Unit
		18 MHz Clock		Variable Clock $1/t_{CLCL} = 3.5 \text{ MHz to } 18 \text{ MHz}$		
		min.	max.	min.	max.	

External Data Memory Characteristics

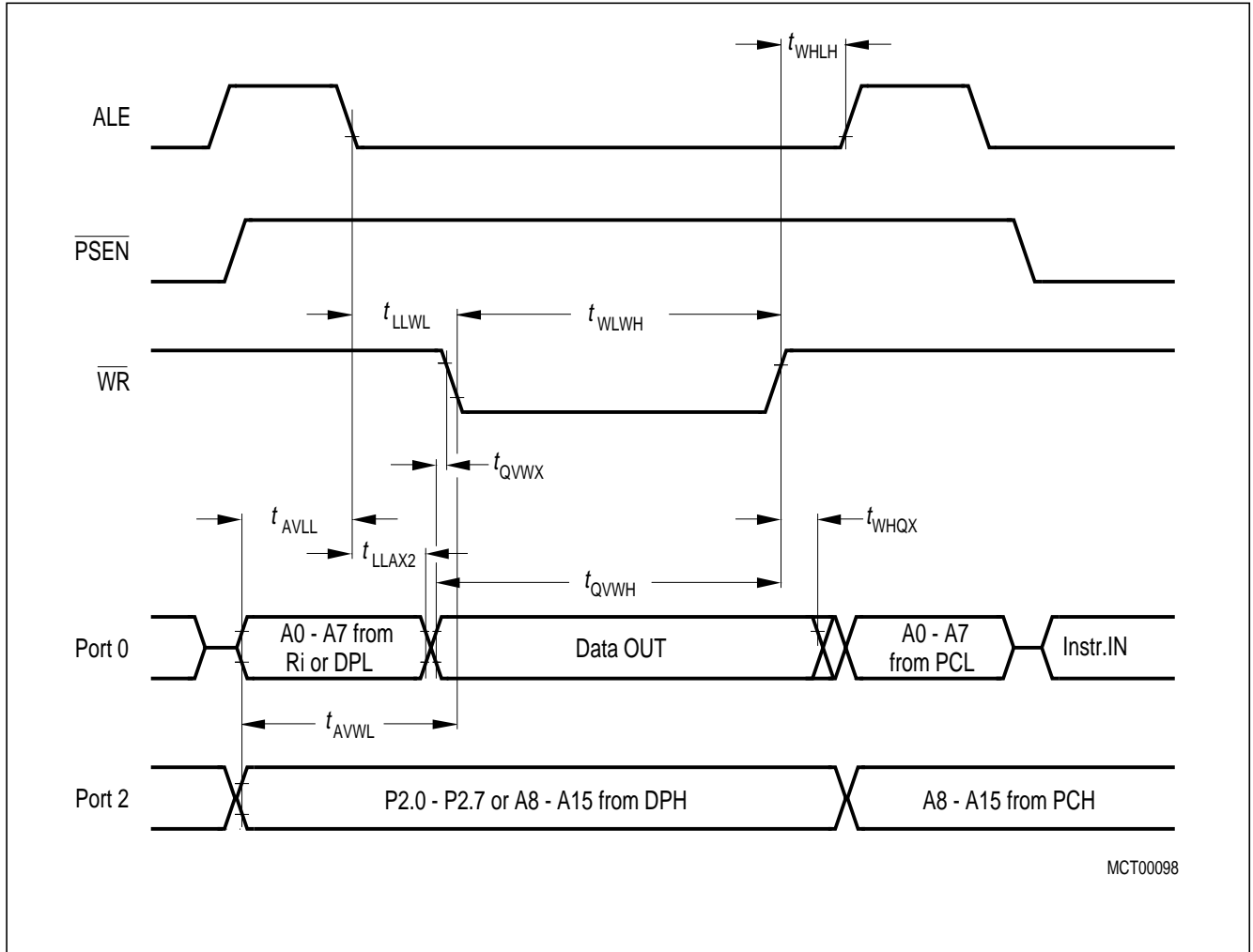
\overline{RD} pulse width	t_{RLRH}	233	–	$6 t_{CLCL} - 100$	–	ns
\overline{WR} pulse width	t_{WLWH}	233	–	$6 t_{CLCL} - 100$	–	ns
Address hold after ALE	t_{LLAX2}	81	–	$2 t_{CLCL} - 30$	–	ns
\overline{RD} to valid data in	t_{RLDV}	–	128	–	$5 t_{CLCL} - 150$	ns
Data hold after \overline{RD}	t_{RHDX}	0	–	0	–	ns
Data float after \overline{RD}	t_{RHDZ}	–	51	–	$2 t_{CLCL} - 60$	ns
ALE to valid data in	t_{LLDV}	–	294	–	$8 t_{CLCL} - 150$	ns
Address to valid data in	t_{AVDV}	–	335	–	$9 t_{CLCL} - 165$	ns
ALE to \overline{WR} or \overline{RD}	t_{LLWL}	117	217	$3 t_{CLCL} - 50$	$3 t_{CLCL} + 50$	ns
\overline{WR} or \overline{RD} high to ALE high	t_{WHLH}	16	96	$t_{CLCL} - 40$	$t_{CLCL} + 40$	ns
Address valid to \overline{WR}	t_{AVWL}	92	–	$4 t_{CLCL} - 130$	–	ns
Data valid to \overline{WR} transition	t_{QVWX}	11	–	$t_{CLCL} - 45$	–	ns
Data setup before \overline{WR}	t_{QVWH}	239	–	$7 t_{CLCL} - 150$	–	ns
Data hold after \overline{WR}	t_{WHQX}	16	–	$t_{CLCL} - 40$	–	ns
Address float after \overline{RD}	t_{RLAZ}	–	0	–	0	ns



Program Memory Read Cycle



Data Memory Read Cycle



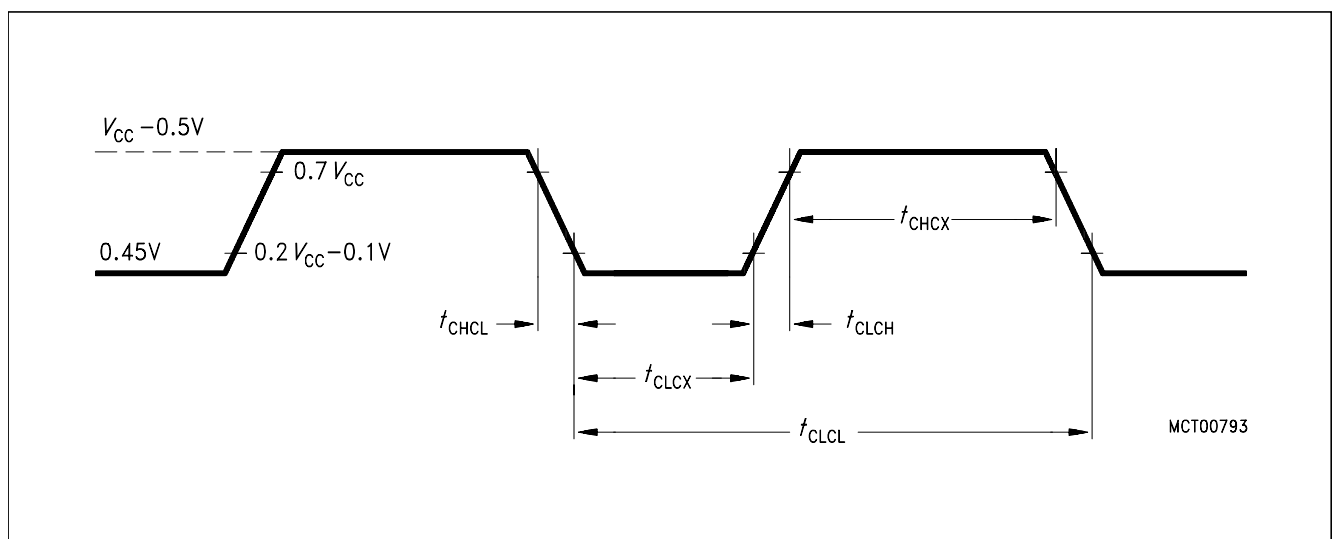
Data Memory Write Cycle

AC Characteristics (cont'd)

Parameter	Symbol	Limit Values		Unit
		Variable clock Frequ. = 3.5 MHz to 18 MHz		
		min.	max.	

External Clock Drive

Oscillator period	t_{CLCL}	55.6	285	ns
High time	t_{CHCX}	20	$t_{CLCL} - t_{CHCX}$	ns
Low time	t_{CLCX}	20	$t_{CLCL} - t_{CHCX}$	ns
Rise time	t_{CLCH}	-	20	ns
Fall time	t_{CHCL}	-	20	ns
Oscillator frequency	$1/t_{CLC}$	3.5	18	MHz



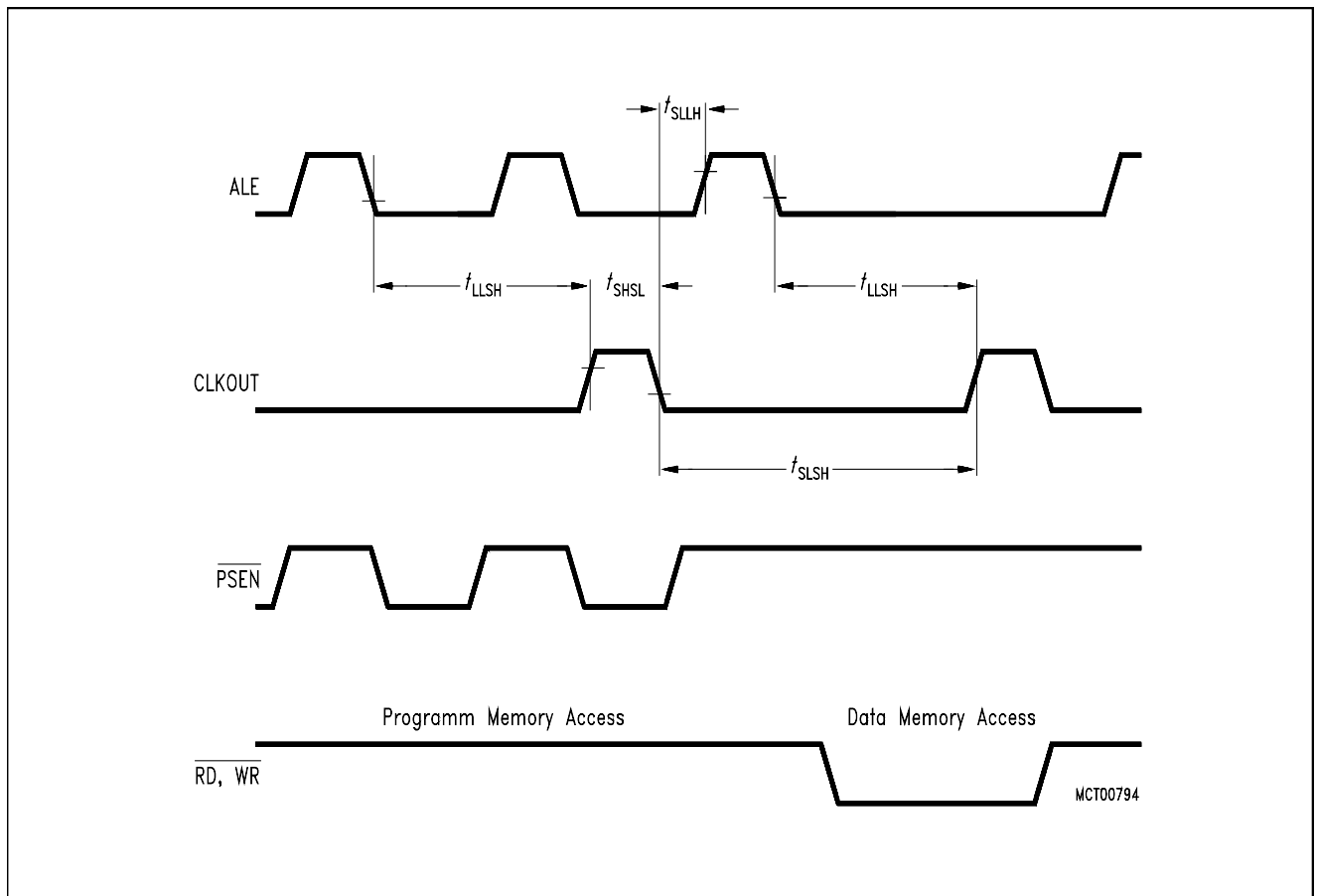
External Clock Cycle

AC Characteristics (cont'd)

Parameter	Symbol	Limit Values				Unit
		18 MHz clock		Variable Clock $1/t_{CLCL} = 3.5 \text{ MHz to } 18 \text{ MHz}$		
		min.	max.	min.	max.	

System Clock Timing

ALE to CLKOUT	t_{LLSH}	349	—	$7 t_{CLCL} - 40$	—	ns
CLKOUT high time	t_{SHSL}	71	—	$2 t_{CLCL} - 40$	—	ns
CLKOUT low time	t_{SLSH}	516	—	$10 t_{CLCL} - 40$	—	ns
CLKOUT low to ALE high	t_{SLLH}	16	96	$t_{CLCL} - 40$	$t_{CLCL} + 40$	ns



System Clock Timing

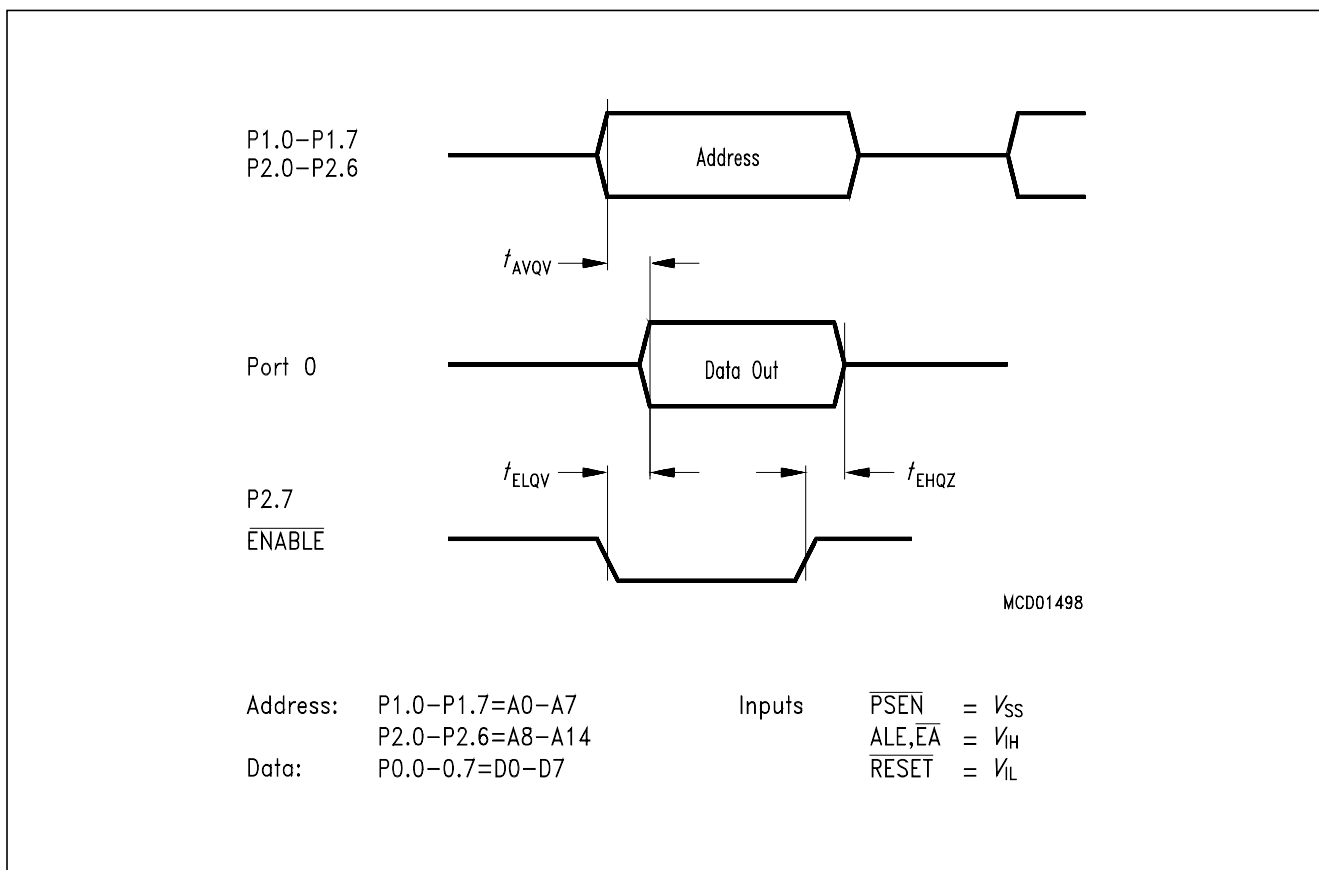
ROM Verification Characteristics

$T_A = 25^\circ\text{C} \pm 5^\circ\text{C}$; $V_{CC} = 5\text{ V} \pm 10\%$; $V_{SS} = 0\text{ V}$

Parameter	Symbol	Limit Values		Unit
		min.	max.	

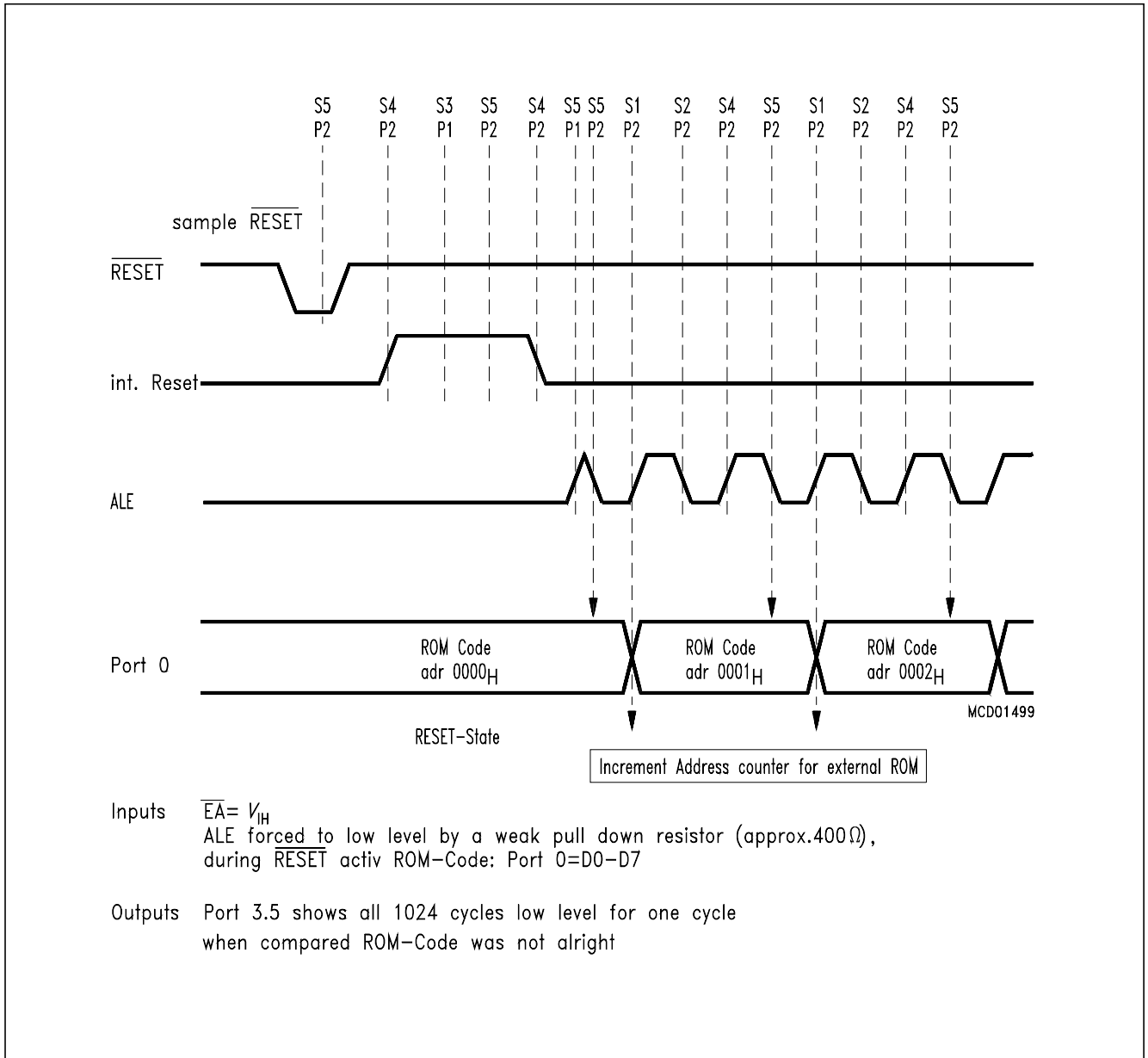
ROM Verification Mode 1 (Standard Verify Mode for not Read Protected ROM)

Address to valid data	t_{AVQV}	-	$48 t_{CLCL}$	ns
ENABLE to valid data	t_{ELQV}	-	$48 t_{CLCL}$	ns
Data float after ENABLE	t_{EHOZ}	0	$48 t_{CLCL}$	ns
Oscillator frequency	$1/t_{CLCL}$	4	6	MHz

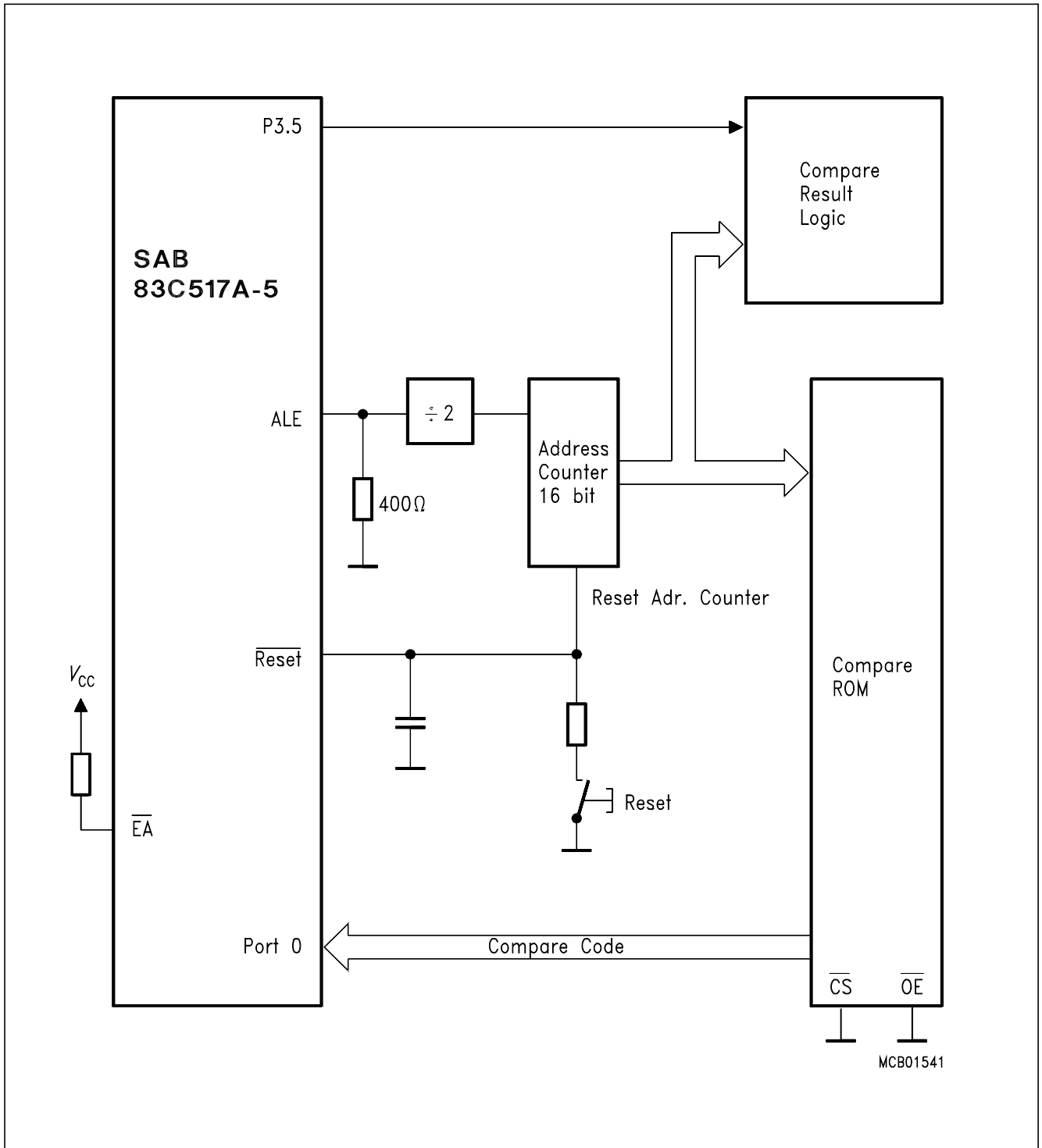


ROM Verification Mode 1

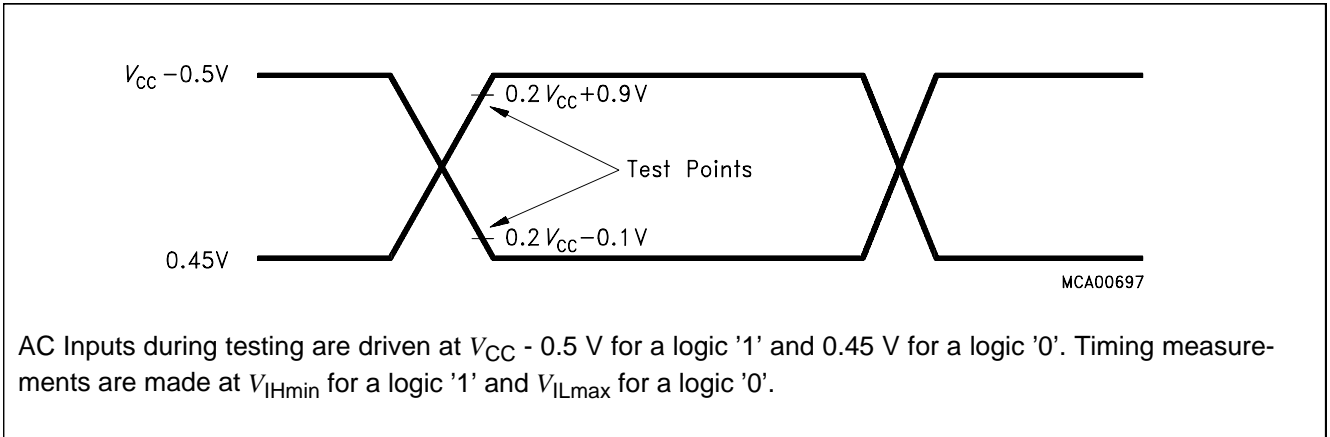
ROM Verification Mode 2 (New Verify Mode for Protected and not Protected ROM)



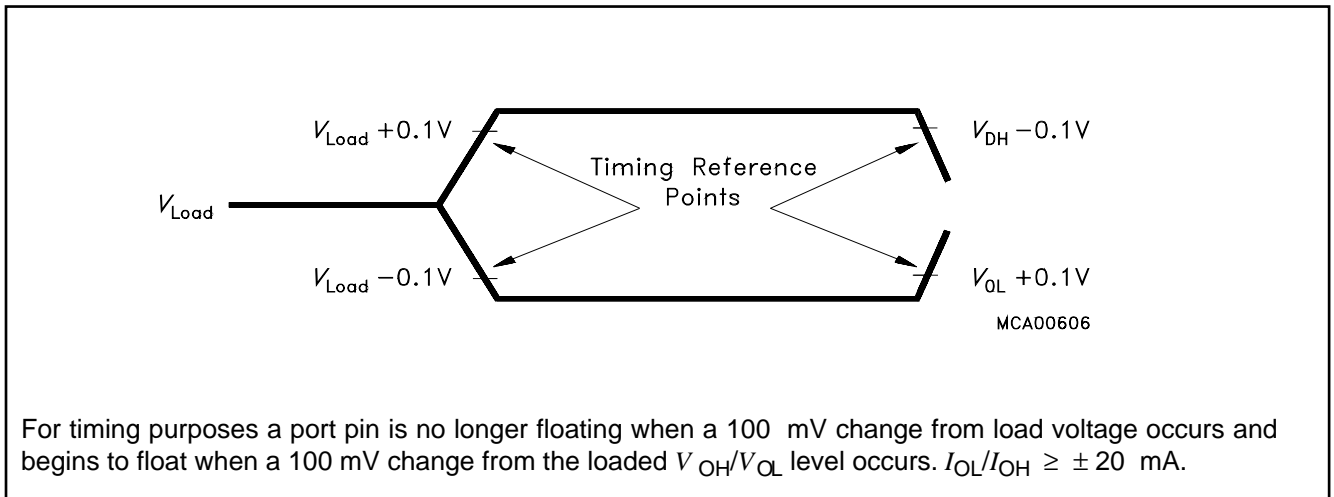
ROM Verification Mode 2



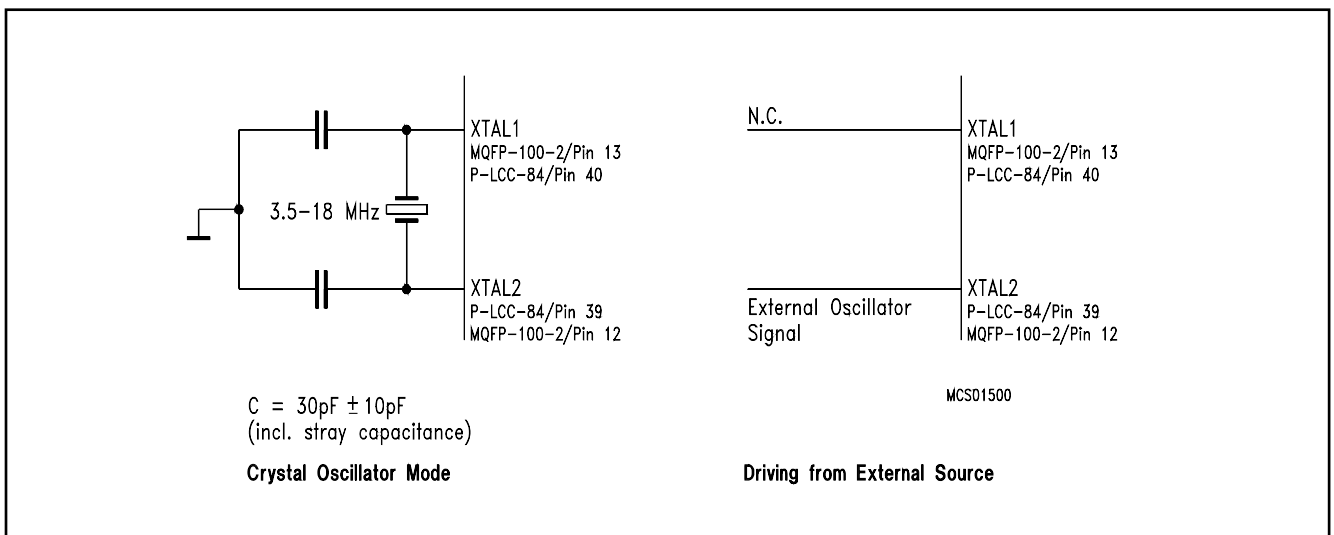
Application Circuitry for Verifying the Internal ROM



AC Testing: Input, Output Waveforms



AC Testing: Float Waveforms



Recommended Oscillator Circuits

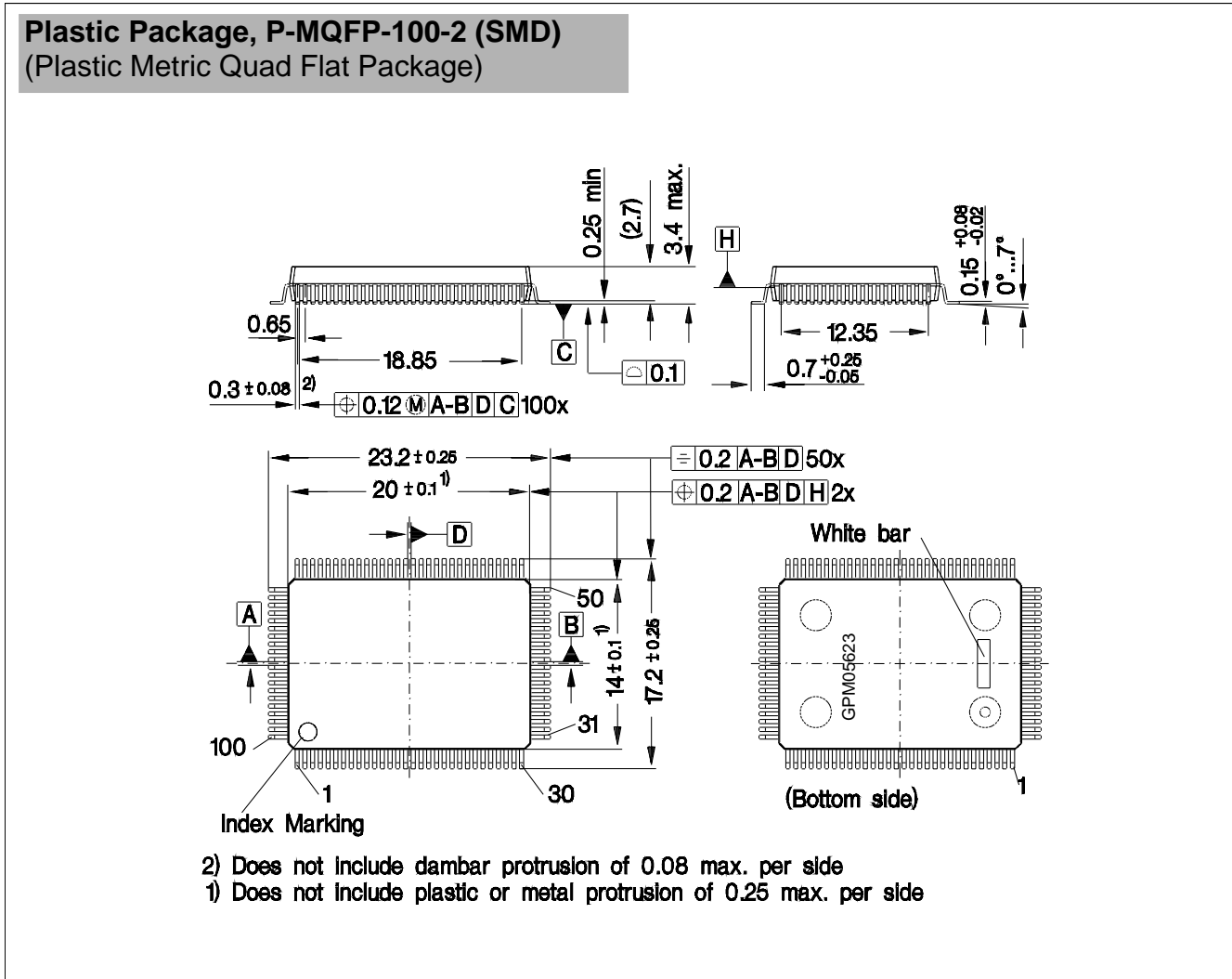


Figure 1
 P-MQFP-100-2 Package Outlines

Sorts of Packing

Package outlines for tubes, trays etc. are contained in our Data Book "Package Information"

SMD = Surface Mounted Device

Dimensions in mm

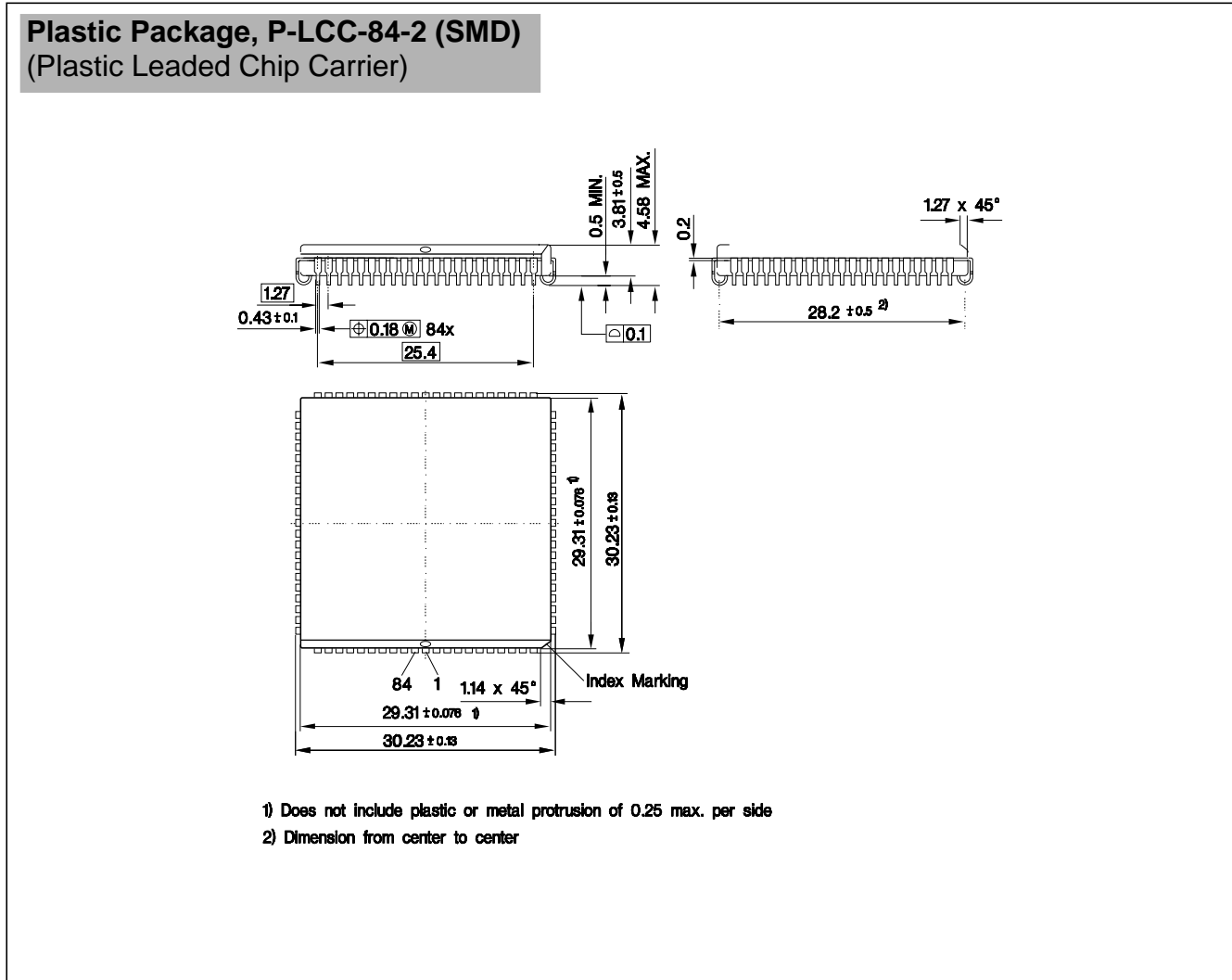


Figure 2
P-LCC-84-2 Package Outlines

Sorts of Packing

Package outlines for tubes, trays etc. are contained in our Data Book "Package Information"

SMD = Surface Mounted Device

Dimensions in mm